

# TekExpress<sup>®</sup> Ethernet Electrical Testing Application Printable Application Help





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#### **Contacting Tektronix**

Tektronix, Inc. 14150 SW Karl Braun Drive P.O. Box 500 Beaverton, OR 97077 USA

For product information, sales, service, and technical support:

- In North America, call 1-800-833-9200.
- Worldwide, visit *www.tek.com* to find contacts in your area.

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## Welcome

Welcome to the TekExpress<sup>®</sup> Ethernet Electrical Testing software application. The application provides more visibility into your Ethernet designs with 1000BASE-T/100BASE-TX/10BASE-T PHY measurements as outlined in IEEE 802.3 Section 40, ANSI X3.263, and IEEE 802.3 Section 14 specific measurements for different Ethernet standards to the already existing rich tool set of generic jitter, timing, and signal quality measurements in Tektronix Oscilloscope.

#### Key features:

- Solution offers most comprehensive Ethernet PHY test coverage supporting multiple speeds.
- Highly optimized, intuitive user interface flow that sets up the test configuration for easy ethernet electrical validation.
- Compliance and margin testing for accurate analysis and improved interoperability.
- Time-domain and frequency-domain measurements made with single analysis instrument.
- Jitter and timing measurements with and without filters.
- Amplitude and droop testing for transmitter performance.
- User-defined mode enables flexible parameter control for characterization and margin analysis. Detailed test reports with margin and statistical information and analysis.
- Ability to modify limits of test parameters in TekExpress for debug and characterization.
- Ability to easily configure multiple test runs.
- Ability to preview test mode waveform prior to running the tests.
- Additional Peak Distortion Vs Phase Offset and Error Values Vs Symbol Number plots for 1000BASE-T distortion test.
- Plot panel is available to view the plot for Return Loss measurement.

# Getting help and support

### Conventions

Help uses the following conventions:

- The term "Application" and "Software" refers to the TekExpress Ethernet Electrical Testing Application.
- The term "DUT" is an abbreviation for Device Under Test.
- The term "select" is a generic term that applies to the different methods of choosing a screen item (button, control, list item): using a mouse or using the touch screen.

Icon	Meaning
COCCUS Sector Sector Sector Sector Sector Sector Sector Sector Sector Sector	This icon identifies important information.
$\wedge$	This icon identifies conditions or practices that could result in loss of data.
8	This icon identifies additional information that will help you use the application more efficiently.

### **Related documentation**

The following documentation is available as part of the TekExpress<sup>®</sup> Ethernet Electrical Testing Application.

### **Table 1: Product Information**

Item	Purpose	Location
Help	Application operation and User Interface help	
PDF of help	Printable version of the compiled help	PDF file that ships with TekExpress Ethernet solution (TekExpress-Ethernet-Solution- Software-Printable-Help-EN- US.pdf). You can download the PDF version of the manual from the Tektronix website. Part number: 077-1504-02 www.tek.com

### **Technical support**

Tektronix values your feedback on our products. To help us serve you better, please send us your suggestions, ideas, or comments on your application or oscilloscope. Contact Tektronix through mail, telephone, or the Web site, *www.tek.com* 

When you contact Tektronix Technical Support, please include the following information (be as specific as possible):

- **General Information** All instrument model numbers
  - Hardware options, if any
  - Probes used
  - Vour name, company, mailing address, phone number, and FAX number
  - Please indicate if you would like to be contacted by Tektronix about your suggestion or comments.

## Application Specific Software version number

- Description of the problem such that technical support can duplicate the problem
- If possible, save the setup files for all the instruments used and the application.
- If possible, save the TekExpress setup files, log.xml, \*.TekX (session files and folders), and status messages text file.
- If possible, save the waveform on which you are performing the measurement as a .wfm file.

# **Getting started**

### Minimum system requirements

The following table shows the minimum system requirements to install and run the TekExpress Ethernet solution.

Component	Description				
Oscilloscope	MSO/DPO5000, DPO7000C and MSO/DPO70000C/DX/SX				
Firmware	Firmware Version: 10.10.1 or above for Windows 10				
	Firmware 10.8.3 only for Windows 7				
Software	IronPython 2.7.3 installed				
	PyVisa 1.0.0.25 installed				
	Microsoft .NET 4.0 Framework				
	<ul> <li>Microsoft Internet Explorer 7.0 SP1 or greater, or other Web browse for viewing reports</li> </ul>				
	<ul> <li>Adobe Reader software 7.0 or greater for viewing portable document format (PDF) files</li> </ul>				

#### **Table 2: System requirements**

## Instruments and accessories required

The following table lists the instruments and accessories required for this application.

Table 3: Instruments and accessories required for Ethernet application

Instrument/Accessory	Model number	Quantity
Oscilloscope	MSO/DPO5000, DPO7000C and MSO/DPO70000C/DX/SX	One
Arbitrary Function Generator	AFG3000 AFG31102 AFG31152 AFG31252	One
Arbitrary Waveform Generator	<ul><li>AWG520x</li><li>AWG5000 Series</li><li>AWG7000 Series</li></ul>	One
Fixtures	TF-GBE-BTP 1000/100/10BASE-T Basic Test Package (consists of test fixture PCB set and RJ45 interconnect cable).	One
	TF-GBE-JTC 103 meter 1000BASE-T jitter test channel cable	One
	TF-GBE-SIC (Short 4-inch (0, 1-meter) RJ45 interconnect cable)	One
Differential Probes	<ul> <li>TDP1500</li> <li>P6247</li> <li>P6248</li> <li>TDP3500</li> </ul>	Two

#### NOTE.

- TF-GBE-ATP fixture set contains TF-GBE-BTP and TF-GBE-JTC fixtures.
- *TF-GBE-BTP fixture set contains TF-GBE-SIC.*
- *TF-GBE-BTP is required for Jitter-Slave test only.*
- TPA-BNC adapter is required for P6247 and P6248 differential probes.
- *For 1000BASE-T Slave jitter testing an additional differential probe is required.*

### Installing the software

Complete the following steps to download and install the latest Ethernet application. See *Minimum system requirements* for compatibility.

- 1. Go to *www.tek.com*.
- 2. Click **Downloads**. In the Downloads menu, select DOWNLOAD TYPE as Software and enter *Ethernet* in the MODEL OR KEYWORD field and click **SEARCH**.



- **3.** Select the latest version of software and follow the instructions to download. Copy the executable file to the oscilloscope.
- **4.** Double-click the executable and follow the on-screen instructions. The software is installed at *C:\Program Files\Tektronix\TekExpress\TekExpress Ethernet*.
- 5. Select Applications > TekExpress Ethernet from the TekScope menu to *Launch the application*.

### **Application directories**

TekExpress Ethernet<br/>applicationThe TekExpress Ethernet application files are installed at the following location:<br/>C:\Program Files\Tektronix\TekExpress Ethernet

AWG Waveforms
Bin
Compliance Suites
Examples
ICP
Images
Lib
Miscellaneous
Report Generator
Tools

The following table lists the application directory names and their purpose:

Directory names	Usage	
AWG Waveforms	Contains waveform files	
Bin	Contains TekExpress Ethernet application libraries	
Compliance Suites	Contains compliance-specific files	
Examples	Contains examples for SCPI commands	
ICP	Contains instrument and TekExpress Ethernet application- specific interface libraries	
Images	Contains images of the TekExpress Ethernet application	
Lib	Contains utility files specific to the TekExpress Ethernet application	
Miscellaneous	Contains log files	
Report Generator	Contains style sheets for report generation	
Tools	Contains instrument and TekExpress Ethernet application- specific files	

#### Table 4: Application directories and usage

See also View test-related files File name extensions

File name extensions

The TekExpress Ethernet application uses the following file name extensions:

File name extension	Description
.TekX	Application session files (the extensions may not be displayed)
.py	Python sequence files
.xml	Test-specific configuration information (encrypted) files Application log files
.CSV	Test result reports Plot data
.mht	Test result reports (default) Test reports can also be saved in HTML format
.pdf	Test result reports Application help documents
.xslt	Style sheet used to generate reports

See also View test-related files Application directories

### View software version

Use the following instructions to view version information for the application and for the application modules such as the Programmatic Interface and the Programmatic Interface Client.

To view version information for Ethernet, click **v** button in the TekExpress application and select **About TekExpress**.

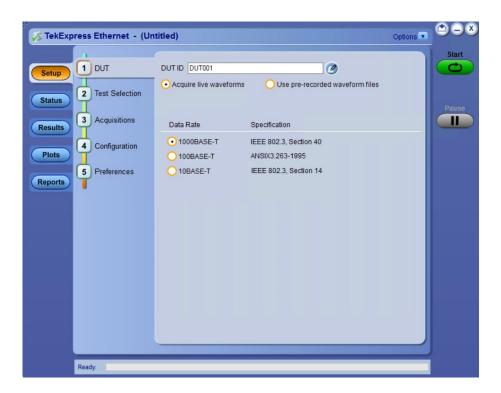


**NOTE.** This example shows a typical Version Details dialog box, and may not reflect the actual values as shown when you open this item in the application.

## **Operating basics**

### Launch the application

To launch the TekExpress Ethernet solution, select **Applications > TekExpress Ethernet** from the TekScope menu.



When you launch the application for the first time, the file C:\Users\<username> \My Documents\My TekExpress\Ethernet\Resources.xml is mapped to drive X:. This file contains information about available network-connected instruments. The session files are stored in X:\Ethernet\. If this file is not found, then the application runs Instrument Discovery Program to detect the network-connected instruments before launching Ethernet solution.

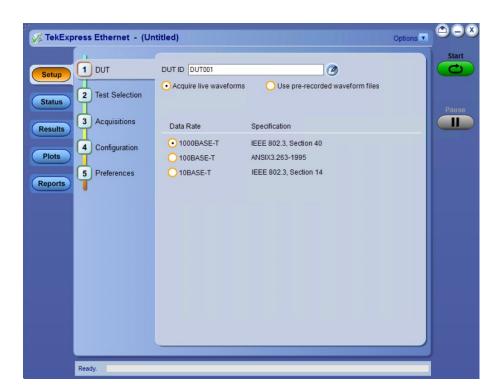
If the application is behind the oscilloscope application, click **Applications** > **TekExpress Ethernet** to bring it to the front. To keep the Ethernet application window on top, select **Keep On Top** from the Ethernet *Options menu*.

**NOTE.** *After installing the application, wait until the instruments gets discovered in the TEKVISA before launching the application.* 

See also Application controls Application panel overview

### Application panels overview

TekExpress Ethernet solution uses panels to group Configuration, Results, and Reports settings. Click any button to open the associated panel. A panel may have one or more tabs that list the selections available in that panel. Controls in a tab can change depending on settings made in the same tab or another tab.



Panel Name	Purpose
Setup panel	The Setup panel shows the test setup controls. Click the <b>Setup</b> button to open this panel. Use this panel to:
	Set DUT tab parameters
	Select tests
	Set acquisition tab parameters
	Set configuration tab parameters
	Set preferences tab parameters
Status panel	View the progress and analysis status of the selected tests, and view test logs.
Results panel	View the summary of test results and select result viewing preferences.
Plots panel	View the plot for Return Loss measurement. Plot is displayed as a two dimensional plot for additional measurement analysis.
Reports panel	Browse for reports, save reports as specific file types, specify report naming conventions, select report content to include (summary information, detailed information, user comments, setup configuration, application configuration), and select report viewing options.

### Table 5: Application panels overview

See also Application controls

## **Global application controls**

Application controls

This section describes the application controls.

#### Table 6: Application controls description

Item	Description
Options menu	To select global application controls.
Test Panel buttons	Controls that open tabs for configuring test settings and options.
Setup Status Results Plots Reports	
Start / Stop button	Use the Start button to start the test run of the measurements in the selected order. If prior acquired measurements are not cleared, then new measurements are added to the existing set. The button toggles to the Stop mode while tests are running. Use the Stop button to abort the test.
Pause / Continue button	Use the Pause button to pause the acquisition. When a test is paused, this button toggles to <b>Continue</b> .

Item	Description
Clear button	Use the Clear button to clear all existing measurement results. Adding or deleting a measurement, or changing a configuration parameter of an existing measurement, also clears measurements. This is to prevent the accumulation of measurement statistics or sets of statistics that are not coherent. This button is available only on <i>Results panel</i> .
Application window move icon	Place the cursor over the three-dot pattern in the upper left corner of the application window. When the cursor changes to a hand, drag the window to the desired location.
Minimize icon	Click to minimize the application.
Close icon	Click to close the application.
Mini view / Normal view	Toggles the application between mini view and normal view. Mini view displays the run messages with the time stamp, progress bar, Start / Stop button, and Pause / Continue button. The application moves to mini view when you click the Start button.
	With the second seco

See also. *Application panel overview* 

Options menu overview

To access Options menu, click 🗾 in the upper-right corner of the application.

Opt	tions menu	
	Default Test Setup	
	Open Test Setup	
	Save Test Setup	
	Save Test Setup As	
	Open Recent	>
	Instrument Control Settings	
	Keep On Top	
	Email Settings	
	Help	
	About TekExpress	

Menu	Function			
Default Test Setup	Opens an untitled test setup with defaults selected. Acquire Live Waveforms. Data rate: 1000BASE-T.			
Open Test Setup	Opens a saved test setup.			
Save Test Setup	Saves the current test setup.			
Save Test Setup As	Saves the current test setup with a different file name or file type.			
Open Recent	Displays the recently opened test setups to open.			
Instrument Control Settings	Detects, lists, and refreshes the connected instruments found on specified connections (LAN, GPIB, USB, and so on).			
Keep On Top	Keeps the TekExpress Ethernet application on top of all applications.			
Email Settings	Use to configure email options for test run and result notification.			
Help	Displays the TekExpress Ethernet help.			
About TekExpress	<ul> <li>Displays application details such as software name, version number, and copyright.</li> </ul>			
	Provides a link to the end-user license agreement.			
	Provides a link to the Tektronix Web site.			

See also. *Application controls* 

# TekExpress instrument control settings

Use TekExpress Instrument Control Settings dialog box to search the instruments (resources) connected to the application. You can use the Search Criteria to search the connected instruments depending on the connection type. The details of the connected instrument is displayed in the Retrieved Instruments window.

You can access this dialog box from the **Options** menu.

LAN		Serial	Non - VISA Res	ources	
	USB	VXI	_	Refre	sh TekVISA 300 Timeout
Connection	ument	Resource	Serial No	Options	Resource Addr
VISA-GPIB		DPO77002SX	PQ100011	50XL,VET,SR-CU	GPIB8::1::INSTR

The connected instruments displayed here can be selected for use under Global Settings in the test configuration section.

**NOTE.** Select GPIB (Default) when using TekExpress Ethernet application.

See also. Options menu overview

View connected instruments Use TekExpress Instrument Control Settings dialog box to search the instruments (resources) connected to the application. The application uses TekVISA to discover the connected instruments.

**NOTE.** The instruments required for the test setup must be connected and it must be recognized by the application before running the test.

To refresh the list of connected instruments:

- 1. From the Options menu, select Instrument Control Settings.
- 2. In the Search Criteria section of the Instrument Control Settings dialog box, select the connection types of the instruments to search.

Instrument search is based on the VISA layer, but different connections determine the resource type, such as LAN, GPIB, and USB. For example, if you choose LAN, the search will include all the instruments supported by TekExpress that are communicating over the LAN.

3. Click Refresh. TekExpress searches for connected instruments.



**4.** After searching, the dialog box lists the instrument-related details based on the search criteria. For example, For the Search Criteria as LAN and GPIB, the application displays all LAN and GPIB instruments connected to the application.

LAN 🗸 GP		Non - VISA Re	sources	
TekLink 🚺 US	B 🔽 VXI		Refre	sh TekVISA 300 s
Retrieved Instrume	nts (1)			
Connection	Resource	Serial No	Options	Resource Addr
VISA-GPIB	DPO77002SX	PQ100011	50XL,VET,SR-CL	J GPIB8::1::INSTR

The details of the instruments are displayed in the Retrieved Instruments table. The time and date of instrument refresh is displayed in the Last Updated field.

See also. 1000BASE-T connection setup 100BASE-T connection setup 10BASE-T connection setup

## Configure email settings

Use the Email Settings utility to get notified by email when a measurement completes, or produces any error condition. Follow the steps to configure email settings:

- 1. Select **Options > Email Settings** to open the *Email Settings* dialog box.
- 2. (Required) For Recipient email Address(es), enter one or more recipient email addresses. To include multiple addresses, separate the addresses with commas.
- **3.** (Required) For Sender's Address, enter the email address used by the instrument. This address consists of the instrument name, followed by an underscore, followed by the instrument serial number, then the @ symbol, and the email server ID. For example: user@yourcompany.com.
- 4. (Required) In the Server Configuration section, type the SMTP Server address of the Mail server configured at the client location, and the SMTP Port number, in the corresponding fields.

If this server requires password authentication, enter a valid login name, password, and host name in the corresponding fields.

**NOTE.** If any of the above required fields are left blank, the settings will not be saved and email notifications will not be sent.

- 5. In the Email Attachments section, select from the following options:
  - **Reports**: Select to receive the test report with the notification email.
  - Status Log: Select to receive the test status log with the notification email. If you select this option, then also select whether you want to receive the full log or just the last 20 lines.
- 6. In the Email Configuration section:
  - Enter a maximum file size for the email message. Messages with attachments larger than this limit will not be sent. The default is 5 MB.
  - Enter the number in the Number of Attempts to Send field, to limit the number of attempts that the system makes to send a notification. The default is 1. You can also specify a timeout period.
- 7. Select the **Email Test Results When complete or on error** check box. Use this check box to quickly enable or disable email notifications.
- 8. To test your email settings, click Test Email.
- 9. To apply your settings, click Apply.
- 10. Click Close when finished.

### **Email Settings**

Email Settings Recipient e-mail Address(es)	
Note: Separate Email address	ses with a comma
Sender's Address	
Email Attachments	Server Configuration
✔ Reports	SMTP Server SMTP Port
🖌 Status Log 📀 Last 20 Lines 🔵 Full Log	Login
	Password
	Host Name
Email Configuration	
Max Email Size (MB) 5	Number of Attempts to Send 1
Timeout (Sec) 0	
Email Test Results When complete or on error	Test Email Apply Close

## Setup panel

**Setup panel overview** The Setup panel contains sequentially ordered tabs that help you guide through the test setup and execution process.



### Set DUT parameters

Use the DUT tab to select parameters for the device under test. These settings are global and apply to all tests of current session. The DUT settings also affect the list of available tests in the Test Selection tab.

TekExpress Ethernet - (Unt	itled)		Options 💌	
Vertexpress Ethernet - (Unt Setup 1 DUT 2 Test Selection 3 Acquisitions 4 Configuration Plots 5 Preferences Reports 7 Preferences	ittled) DUT ID DUT001 • Acquire live waveforms Data Rate • 1000BASE-T • 100BASE-T • 100BASE-T • 100BASE-T	Use pre-recorded waveform files Specification IEEE 802.3, Section 40 ANSIX3.263-1995 IEEE 802.3, Section 14	Options •	Pause
Ready.				

Click **Setp > DUT** to access the DUT parameters:

### Table 7: DUT tab settings

Setting	Description
DUT ID	Adds an optional text label for the DUT to reports. The default value is DUT001. The maximum number of characters is 32. You cannot use the following characters in an ID name: (.,,, $?"<> *)$
Comments icon (to the right of the DUT ID field)	Opens Comments dialog box to enter text to add to the report. Maximum size is 256 characters. To enable or disable comments appearing on the test report, see <i>Select report options</i> .
Acquire live waveforms	Perform analysis on live waveforms.
Use pre-recorded waveform files	Perform analysis on pre-recorded waveforms.
Data Rate	
1000BASE-T	IEEE 802.3, Section 40
100BASE-T	ANSIX 3.263-1995
10BASE-T	IEEE 802.3, Section 14

See also. *Select tests* 

# **Select tests** Use the Test Selection tab to select the tests. The test measurements available depends on the standard selected in the DUT tab.

TekExpress Ethernet - (Un Setup DUT 2 Test Selection 3 Acquisitions 4 Configuration	titled) Ethernet : 1000BASE-T : IEEE 802.3, Section esselect Al 1000BASE-T Measurements Without Disturber Without Disturber Template Point A Template Point C Template Point D Template Point D Template Point D	Options •	Start C
Reports Preferences	Template Point H Peak Point A Peak Point B Peak Point C Peak Point C Proop Point G Transmitter Distortion Transmitter Distortion	Schematic and View Waveform	
	Please select a test name to view its description	Preview	
Ready.			

Figure 1: TekExpress Ethernet measurements

### Table 8: Test Selection tab settings

Setting	Description
Deselect All	Click to clear all tests.
Select Required	Click to select all the tests required for compliance.
Select All	Click to select all tests. All tests are selected by default.
Tests	Click on a test to select or unselect. Highlight a test to show details in the Test Description pane.
Test Description	Shows brief description of the highlighted test in the Test field.
Preview	Click to preview the schematic and the expected waveform example for the <b>selected</b> test.

See also. Set acquisition tab parameters

# Set acquisition tab parameters

Use Acquisitions tab to view the test acquisition parameters. The contents displayed on this tab depends on the DUT type and the tests selected.

🖉 TekExp	oress Ethernet - (Un	titled)			Dptions 🔽 🗎 🔍 🔍
Setup Status Results	DUT Test Selection Acquisitions	Test Mode / RL Probe1 Source 1 Slave Clock / Aux Source 3 Aux Channel (Select che Test Name Tenplate Point A	Source CH1 Source CH3 eckbox to us	Source 2 CH	Aurce 42 Alew obes Pause
Plots	5 Preferences	Template Point B Template Point C Template Point D Template Point F Template Point H Peak Point A Peak Point B Peak Point C Peak Point D Drone Point C		TemplateB_Without_Disturber TemplateC_Without_Disturber TemplateD_Without_Disturber TemplateF_Without_Disturber TemplateH_Without_Disturber PeakvoltageA_Without_Disturber PeakvoltageD_Without_Disturber PeakvoltageD_Without_Disturber Decong_Without_Disturber	r r
	Ready.	Acquisition and Save Option Save All Waveforms Delete All Waveforms After	IS	Show Acquire Param	_

**NOTE.** *TekExpress Ethernet application acquires all waveforms needed by each test group before performing analysis.* 

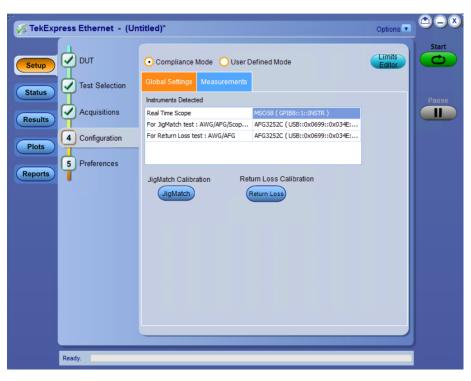
Setting	Description
View Probes	Click to view the detected probe configuration. Use the View Probes dialog box to enable or disable probe signal source access in the application.
Source	Select the signal source for Data, Master Clock and/or Slave Clock for the measurement. Ensure that no two sources have the same channel selected. Same set of channels can be used for Return Loss with a Data as positive input and Master Clock as negative input and Slave Clock for sync input.
Aux	Select to use oscilloscope's Aux channel.
Acquisition and Save Options <ul> <li>Save All Waveforms</li> <li>Delete All Waveforms After Analysis</li> </ul>	<ul> <li>Saves all the waveforms after the analysis.</li> <li>Deletes all the waveforms after the analysis.</li> </ul>
Show Acquire Parameters	Select to view the acquisition parameters.

#### Table 9: Acquisitions tab settings

TekExpress Ethernet saves all acquisition waveforms to files by default. Waveforms are saved in a unique folder for each session (a session is started when you click the Start button). The folder path is X:\Ethernet\Untitled Session \<dutid>\<date>\_<time>. Images created for each analysis, CSV files with result values, reports, and other information specific to that particular execution are also saved in this folder.

Saving a session moves the session file contents from the Untitled Session folder to the specified folder name, and changes the session name to the specified name.

**Set configuration tab** parameters Use Configuration tab to view and configure the Global Settings and the measurement configurations. The Global Settings and the measurements with configurations available in this tab depends on the Standards selected in the DUT tab.





🖉 TekExpress Ethernet - (U	titled)* Or	ptions 🔽 🖄 😑
	Compliance Mode User Defined Mode	imits ditor
Status V Test Selection	Global Settings Measurements	
Results Acquisitions	Template Point A Template Point B Template Point C Template Point D	
Plots 4 Configuration		
Reports 5 Preferences	Peak Point A Peak Point B Peak Point C Peak Point D	•
	Acquire Acquisition Average 64	
	Analyze Trigger Level (A) 0.5 V	
	Trigger Level (B) 0.15 V	
Ready.		

Figure 3: Configuration tab: Measurements Settings

### Table 10: Configuration tab settings

Setting	Description
Compliance Mode	Select to run test(s) in compliance mode. By default Compliance Mode is selected.
User Defined Mode	Select to run test(s) in user defined mode.
Global Settings	
Instruments Detected	Displays the instruments connected to this application. Click on the instrument name to open a list of available (detected) instruments.         Select Options > Instrument Control Settings and click Refresh to update the instrument list.         NOTE. Verify that the GPIB search criteria (default setting) in the Instrument Control Settings is selected when using TekExpress Ethernet application.
JigMatch Calibration	Measures the Amplitude and the Frequency of the disturbing signals. The default values can be set. The application measures and displays the values in the Measured Value fields. You can validate the disturbing signal by comparing the Measured Value with the Expected Value.
Return Loss Calibration	Displays the schematics for Return Loss Calibration. The Transmitter and Receiver Return Loss calibration for OPEN, SHORT, and LOAD terminations can be performed.

# Table 11: Measurements configuration for Analyze 1000BASE-T

Measurements	Configuration		Value
Template Point A Template Point B Template Point C Template Point D Template Point F Template Point H Template Point A (D) Template Point B (D) Template Point C (D) Template Point C (D) Template Point F (D) Template Point H (D) Peak Point A Peak Point B	Configuration         Analyze	External Filter	Value Include or Exclude
Peak Point C Peak Point D Peak Point A (D) Peak Point B (D) Peak Point C (D) Peak Point D (D)			
Transmitter Distortion Without TX_TCLK	Analyze	LP Filter	Include or Exclude
Transmitter Distortion With TX_TCLK Transmitter Distortion Without TX_TCLK (D) Transmitter Distortion With TX_TCLK (D)		Hi Resolution	16 to 64
Master Filtered Without TX_TCLK Master UnFiltered Without TX_TCLK		Clock Edge	RISE, FALL

Measurements	Configuration		Value
Slave Filtered Without TX_TCLK Slave UnFiltered Without TX_TCLK Master Filtered With TX_TCLK Master UnFiltered With TX_TCLK Slave Filtered With TX_TCLK Slave UnFiltered With TX_TCLK		Hysteresis	0% - 10 %
Transmitter Return Loss	Analyze	Smoothing Averages	1 to 10
		Loads (Ohm)	<ul><li>85, 100, 115</li><li>100</li></ul>
CM Voltage		Filter Type	<ul> <li>None</li> <li>1 MHZ(High Pass)</li> <li>100 MHz(Low Pass)</li> <li>(1-100) MHz(Baseband)</li> </ul>

# Table 12: Measurements configuration for Analyze 100BASE-T

Measurements	Configuration		Value
AOI Template	Analyze	Polarity	<ul> <li>Both</li> <li>Pos</li> <li>Neg</li> </ul>
Fall Time (Pos) Fall Time (Neg) Rise Time (Pos) Rise Time (Neg) RF Symmetry (Pos) RF Symmetry (Neg) Overshoot (Pos) Overshoot (Neg) Differential Output Voltage (Pos) Differential Output Voltage (Neg) Amplitude Symmetry Jitter	Analyze	Fail Threshold         Measurement Type	1 to 5000
Duty Cycle Distortion	_		
Receiver Return Loss Transmitter Return Loss		Smoothing Averages Loads(Ohm)	1 to 10 85, 100, 115 100

Measurements	Configuration		Value
Link Pulse Load With TPM	Analyze	Mark Selection	Head, Tail, Both
Link Pulse Load Without TPM		Fail Threshold	1
Link Pulse Timing With TPM	Analyze		
Link Pulse Timing Without TPM			
Differential Voltage	Analyze	Peak	Min
TP_IDL Load Without TPM TP_IDL Load With TPM			Min Max
		Mark Selection Fail Threshold	Head, Tail, Both 1
Jitter Normal with TPM	Analyze	MAU Type	Internal
Jitter Normal without TPM			External
Jitter 8.0 with TPM			
Jitter 8.0 without TPM			
Jitter 8.5 with TPM			
Jitter 8.5 without TPM			
MAU Internal		Fail Threshold	1
MAU External			
MAU Internal (Inverted)			
MAU External (Inverted)			
Transmitter Return Loss		Smoothing Averages	1 to 10
Receiver Return Loss		Loads (Ohm)	<b>85, 100, 115</b>
			<b>100</b>
	-		- 100
CM Voltage		Filter Type	<ul> <li>None</li> </ul>
			<ul> <li>1 MHz (High Pass)</li> </ul>
			<ul> <li>100 MHz (Low Pass)</li> </ul>
			<ul> <li>1-100 MHz (Band pass)</li> </ul>

# Table 13: Measurements configuration for Analyze 10BASE-T

# Table 14: Measurements configuration for Acquire 1000BASE-T

Measurements	Configuration		Value
Template Point A	Acquire	AcquisitionAverage	16 to 256
Template Point B		TriggerLevel (A)	-5 V to 5 V
Template Point C			
Template Point D			
Template Point F			
Template Point H			
Template Point A (D)			
Template Point B (D)			
Template Point C (D)			

Measurements	Configuration	on Value	
Template Point D (D) Template Point F (D) Template Point H (D)		TriggerLevel (B)	-5 V to 5 V
Transmitter Distortion Without TX_TCLK Transmitter Distortion With TX_TCLK Transmitter Distortion Without TX_TCLK (D) Transmitter Distortion With TX_TCLK (D) Peak Point A Peak Point B Peak Point C Peak Point D Droop Point G Droop Point J Peak Point A (D) Peak Point B (D) Peak Point B (D) Peak Point C (D) Droop Point G (D) Droop Point J (D)	Acquire	Acquisition Average	16 to 256
Master Filtered Without TX_TCLK Master UnFiltered Without TX_TCLK Slave Filtered Without TX_TCLK		Measurement Duration	1 ms, 10 ms, 100 ms 1000 ms
Slave UnFiltered Without TX_TCLK Master Filtered With TX_TCLK Master UnFiltered With TX_TCLK Slave Filtered With TX_TCLK Slave UnFiltered With TX_TCLK		Number Of Clock Edges	100000, 1000000, 10000000
Transmitter Return Loss		Acquisition Average	100 to 10000
CM Voltage			

### Table 15: Measurements configuration for Acquire 100BASE-T

Measurements	Configuration		Value
AOI Template	Acquire	Number of samples	5000 to 2147400000
Fall Time (Pos)		Acquisition Type	Sample, Average
Fall Time (Neg) Rise Time (Pos) Rise Time (Neg) RF Symmetry (Pos) RF Symmetry (Neg) Overshoot (Pos) Overshoot (Neg) Differential Output Voltage (Pos) Differential Output Voltage (Neg) Amplitude Symmetry		Number of Waveforms	2 to 10000
Jitter			

Measurements	Configuration		Value
Duty Cycle Distortion		Acquisition Type	Sample, Average
Receiver Return Loss Transmitter Return Loss		Acquisition Average	100 to 10000

# Table 16: Measurements configuration for Acquire for 10BASE-T

Measurement	Configuration		Value
Link Pulse Timing Without TPM Link Pulse Timing With TPM Link Pulse Load Without TPM Link Pulse Load With TPM	Acquire	Number of Acquisitions Number of Waveforms	2 to 10000 1 to 10000
Differential Voltage		Acquisition Average	2 to 1000
		Acquisition Delay	1 to 10000 (Micro-seconds)
		Acquisition Type	<ul><li>Sample</li><li>Average</li></ul>
TP_IDL Load With TPM TP_IDL Load Without TPM	-	Number of Acquisitions Number of Waveforms	2 to 10000 1 to 10000
Jitter Normal with TPM Jitter Normal without TPM Jitter 8.0 with TPM Jitter 8.0 without TPM Jitter 8.5 with TPM Jitter 8.5 without TPM	Acquire	Number of Acquisitions	2 to 10000 1000 to 10000
MAU Internal MAU External MAU Internal (Inverted) MAU External (Inverted)	-		
Harmonic	Acquire	Acquisition Delay	1 to 10000 (Micro-seconds)
		Math Average	2 to 10000
Transmitter Return Loss Receiver Return Loss	Acquire	Acquisition Average	100 to 10000
CM Voltage			

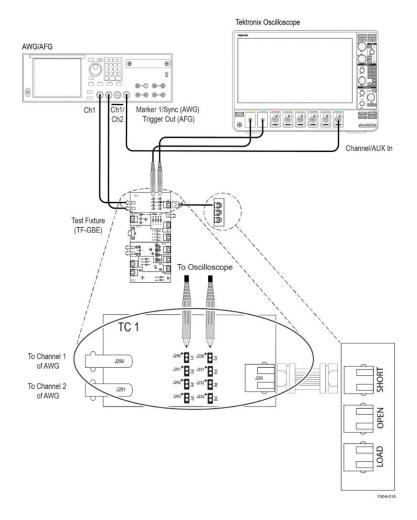
**Return Loss Calibration steps.** You can configure a DUT (Device Under Test) by adjusting it to conform to a dependable measure before running the Return Loss measurement.

Complete OPEN, SHORT, and LOAD calibrations before running the Return Loss measurement.

To run the Return Loss calibration, follow the steps given below:

1. Use TC1 in the test fixture.

Make the connections as shown in the following figure.



#### Figure 4: Connection diagram for SHORT Calibration

- **2.** Connect a BNC Cable between channel 1 of AWG/channel 1 of AFG and J290.
- **3.** Connect a BNC Cable between Ch1/ AWG/channel 2 of AFG and J291.

4. Connect Differential Probes from configured channels of the oscilloscope to P1 and P2 for Transmitter Return Loss, P3 and P4 for Receiver Return Loss.

**NOTE.** Connect the termination SHORT, LOAD, and OPEN to J200 one by one, for calibration.

- **5.** In the TekExpress Ethernet application click the **DUT** panel and select the Suite of interest.
- 6. Click the Acquisitions panel and select the channels for calibration.
- 7. If Aux is selected as Source3 (Trigger Sync Input), select the checkbox.

**NOTE.** Aux channel is present only in 6 Series MSO oscilloscopes.

- 8. In the **Options** > **Instrument Control** settings, refresh to view the connected AWG/AFG.
- **9.** In the **Configuration** Panel, select the Signal source model (*For Return Loss test: AWG/AFG*).
- 10. Click Return Loss.

V TekExpress Ethernet - (	Untitled)*	Options 💌	
Setup Status Results Plots I DUT J DUT V Acquisitions I Configuration	Compliance Mode     User Defined Mode     Global Settings     Measurements     Instruments Detected     Real Time Scope     For JigMatch test : AWG/AFG/Scop AFG3252C (US8::0x06699::0x034E:     For Return Loss test : AWG/AFG     AFG3252C (US8::0x0699::0x034E:	Limits Editor	Start
Reports 5 Preferences	JigMatch Calibration Return Loss Calibration		
Ready.			

Figure 5: Configuration Panel to select Signal Source and to perform Return Loss Calibration

**11.** In the **Calibration** dialog, select Tx for Transmission or Rx for Receiver Return Loss Calibration.

**12.** Perform SHORT, OPEN, and LOAD Calibration one by one with connection changes (detailed below) and click **Apply**. This completes the Return Loss Calibration.

3	100BASE-T Return	Loss Calibration		<u>×</u>
	• Tx	O Rx	Signal Source: AWG5202	Schematic
	Probe1: CH1	Probe2: CH2	Sync Input: CH3	
	<u>Calibration Type</u> Short	<u>Calibration Status</u> Pending	Calibration Time	Calibration
	Open	Pending		Calibration
	Load	Pending		Calibration
			LastApplied:	Apply

Figure 6: Calibration panel before performing calibration

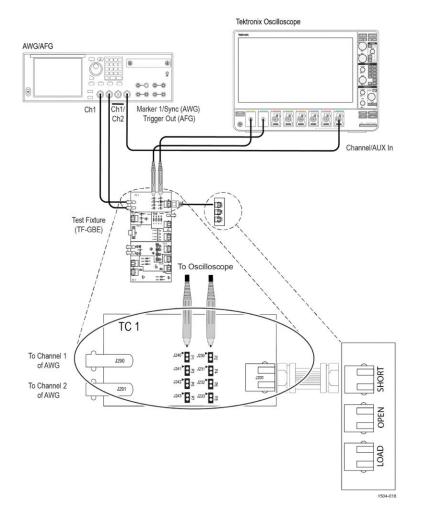
The corresponding date and time for the latest successful Calibration and Apply are displayed.

1000BASE-T Return	n Loss Calibration		×
⊙ Тх	O Rx	Signal Source: AFG31052	Schematic
Probe1: CH1	Probe2: CH2	Sync Input: CH3	
Calibration Type	Calibration Status	Calibration Time	
Short	Completed	05/12/2019 19:52:17	Calibration
Open	Completed	05/12/2019 19:53:12	Calibration
Load	Completed	05/12/2019 19:55:51	Calibration
		LastApplied: 05/12/2019 19:5	5:58 Apply

Figure 7: Calibration panel after calibration is performed for OPEN, SHORT, and LOAD and then Apply

#### SHORT calibration:

Perform the above-mentioned steps with SHORT termination connected to J200 as shown below:

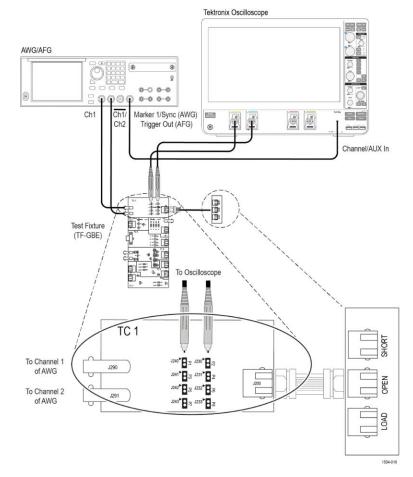


#### Figure 8: Connection diagram for SHORT Calibration

The following figure displays a typical waveform for Return Loss SHORT Calibration.



Figure 9: Calibration output for SHORT calibration



#### **OPEN Calibration:**

Figure 10: Connection diagram for OPEN Calibration

The following figure shows a typical waveform for Return Loss OPEN Calibration.

Ref 1 - FFT			 ×
-			
- '			1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 - 1997 -
- ·			
-			

Figure 11: Calibration output for OPEN calibration

#### LOAD Calibration:

Perform the above mentioned steps with LOAD termination connected to J200 as shown below:

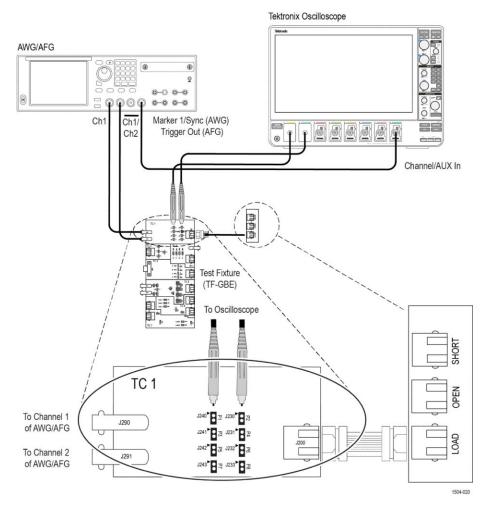


Figure 12: Calibration output for LOAD calibration

The following figure shows a typical waveform for Return Loss LOAD Calibration.



Figure 13: Calibration output for LOAD calibration

After OPEN, SHORT, and LOAD calibration, click **Apply** in Return Loss Calibration window which generates the Return Loss measurements pre-requisite data by using calibration values.

**NOTE.** Clicking Apply will not apply any setting on the oscilloscope nor does any acquisition.

**NOTE.** If you change any of the following configurations, calibration for Open, Short, and Load must be performed again before running the return loss measurement:

- Channels and Trigger Sync input
- Signal Source selected
- Return Loss type (Transmitter or Receiver)

#### Method to set up the Signal Source for *Do not use* configuration:

In Configuration Panel if the Signal source is selected as *For Return Loss test: AWG/AFG* is *Do not use*, then the waveform need to be manually loaded in the Signal Source before running the Calibration or Return Loss measurement.

Instruments Detected		
Real Time Scope	MSO64 (GPIB8::1::INSTR)	
For JigMatch test : AWG/AFG/Scop	Do not use	
For Return Loss test : AWG/AFG	Do not use	



#### Method for loading the waveform on the supported AWG:

Copy the waveform available at Oscilloscope at C:\Program Files\Tektronix \TekExpress\TekExpress Ethernet\AWG Waveforms\10BaseT Return Loss \AWG Format\RL10\_AWG.wfm, to the AWG using LAN or USB. Example mentioned above is for 10BaseT, select the folder accordingly for 1000BaseT or 100BaseT. The above path is applicable for all supported AWG models.

- Open the waveform for the corresponding speed and AWG series from Open File option, and when prompted, select option Max & Preserve Offset settings.
- Set Amplitude to 1.5 Vpp. (Maximum supported Amplitude)
- Click Setup > Clock > set the Sample Rate to 250 MS/s.
- Click Setup > Channel > set the Resolution(bits) to (15 + 1 Mkr).
- Switch **ON** the channel and click **Play**.

	Playing		
Home Setup Waveform Plug-ins Sequence Editor	Capture/Playback Precompensation Utilities		
		Force Trig A Force Trig B All Outputs OH	AWG Functions
Channel 1 RL1000_5000			umplitude 1.500 Vpp
8 Run Continuous •			Offset 0 V
725 mV		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	ukukukukuku
0 21. 4k 6k 8k			38 k 40 k
Channel 2     Click to assign waveform/sequence			implitude 500.0 mVpp
🖁 Run Continuous 👻			Offset 0 V
236 WV			
- Vin 025-			
Sar	ple Rate: 250 MS/s		

Figure 15: AWG with Return Loss waveform loaded

#### Method for loading the waveforms on the supported AFG:

For AFG3000 series:

- Copy the waveform available at Oscilloscope at C:\Program Files\Tektronix \TekExpress\TekExpress Ethernet\AWG Waveforms\10BaseT Return Loss \AFG Format\RL10\_AFG.tfw, to AFG using USB. Example mentioned above is for 10BaseT, select the folder accordingly for 1000BaseT or 100BaseT. The above path is applicable for all supported AFG 3000 series models.
- 2. Click Arb > Arb Waveform menu > USB > select the waveforms (.tfw) on both the channels.
- **3.** Set the **Frequency** to 6.052682549 kHz for 100BaseT and 1000BaseT and 6.097560976 kHz for 10BaseT, for both the channels.
- 4. Set the Amplitude to 2.0 Vpp, for both the channels.
- 5. Invert the waveforms on channel 2.
- 6. Switch ON both the channels.

CH1 Arb	Continuous	CH2 Arb	Continuous
Freq	6.052 682 549 kHz	Freq	6.052 682 549 kHz
Phase	0.0 °	Phase	0.0 °
Ampl	2.000 Vpp	Ampl	2.000 Vpp
Offset	0 mV	Offset	0 mV
Shape	Edit Memory1 🔹	Shape	Edit Memory2
1.000 V 0 mV -1.000 V 0 µs 82.6 µs	165.2 µs 247.8 µs 330.4 µs	1.000 V 0 mV -	165.2 µs 247.8 µs 330.4 µs

Figure 16: AFG with Return Loss waveforms loaded

For AFG31000 series:

- 1. Copy the waveform available at Oscilloscope at *C:\Program Files\Tektronix* \*TekExpress\TekExpress Ethernet\AWG Waveforms\10BaseT Return Loss* \*AFG Format\RL10\_AFG.tfw*, to AFG using USB. Example mentioned above is for 10BaseT, select the folder accordingly for 1000BaseT or 100BaseT. The above path is applicable for all the supported AFG models.
- 2. Click Home > ArbBuilder > Open > USB, select corresponding folder and file (.tfw) and click OK.
- 3. Click Save As and save the waveform on the Memory (.tfwx). Click OK.
- 4. Click Home > Basic > select Arb from drop down menu for the channel 1.
- 5. From Shape > File > USB > select the waveform file for the corresponding speeds from Memory(.tfwx).
- 6. Repeat steps 4 and 5 for channel 2.
- 7. Set the **Frequency** to 6.052682549 kHz for 100BaseT and 1000BaseT and 6.097560976 kHz for 10BaseT, for both the channels.
- 8. Set the Amplitude to 2.0 Vpp, for both the channels.
- 9. Invert the waveforms on channel 2.
- 10. Switch ON both the channels.

**JigMatch calibration steps.** You can measure the Amplitude and Frequency of the disturbing signal and set the default values. The application measures and displays the values in Measured Value fields. You can validate the disturbing signal by comparing the measured value with the expected value.

To do the JigMatch calibration in the TekExpress application follow the steps below:

- 1. In the DUT panel and select the Suite of interest.
- 2. In the Acquisitions panel and select the channel for measurement.
- **3.** In the **Instrument Control** settings, refresh to view the connected AWG/ AFG.
- **4.** From the **Configuration** panel, select the Signal source model in *For JigMatch test: AWG/AFG/Scope AFG.*
- 5. Click JigMatch.

🖉 TekExp	oress Ethernet - (Un	itled)*	Options 🔽 😁 — 🗵
Setup	τυα	Compliance Mode     Ouser Defined Mode	Limits Editor
Status	V Test Selection	Global Settings Measurements	
Results	Acquisitions	Instruments Detected Real Time Scope For JigMatch test : AWG/AFG/Scop AFG3252C (US8::0x0699): For Return Loss test : AWG/AFG AFG3252C (US8::0x0699): For Return Loss test : AWG/AFG	:0x034E:
Plots	5 Preferences		
Reports		JigMatch Calibration	
	Ready.		

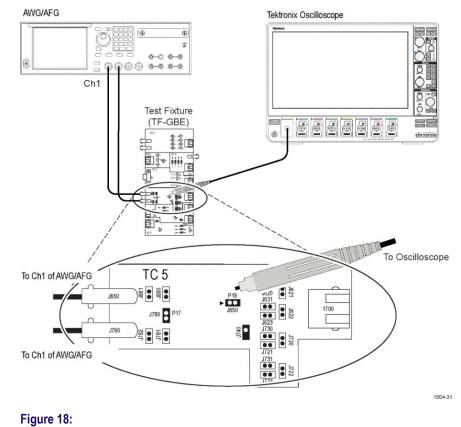


JigMatch calibration includes the following:

- Disturber Compensation
- Test Fixture Compensation Step 1
- Test Fixture Compensation Step 2

To measure the Disturbing Signal using JigMatch, follow the steps given below:

1. Use TC5 of the test fixture.



2. Make the connections as shown in the following figure:

#### NOTE.

- Do not connect the Ethernet cable to J700 and the test port of the DUT.
- Short the jumpers J621, J630, J620, J623, J721, J723, J680, and J781.

Disturber Co Connect Tektr	mpensation onix AWG/AFG to test	fixture	
	Expected Value	Last Measured Valu	e
Amplitude	1.4V	1.4V	Measure
Frequency	31.25MHz	31.25MHz	Default

Figure 19: Disturber Compensation in JigMatch

- **3.** In the **Jig Match** dialog box, click **Measure** in the **Disturber Compensation** group box.
- 4. Compare the Measured Value with the Expected Value.
- **5.** If the Measured Value is not approximately equal to the Expected Value, modify the amplitude and clock frequency settings of the Arbitrary Waveform Generator/Arbitrary Function Generator. Click **Measure** and compare the values until it is approximately equal.

To compensate the linearities of Test Fixture (TC2) using JigMatch, follow the steps given below:

Test Fixture Compensation, Step 1:

- **1.** Use TC2 of the test fixture.
- 2. Make the connections as shown in the following figure.

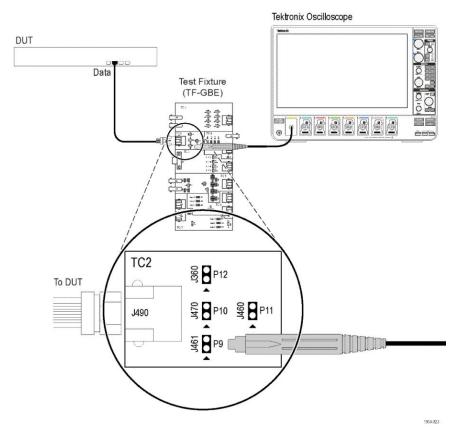


Figure 20: Connection diagram to measure linearities of Test Fixture using JigMatch

- **3.** For Template, Droop, and Peak Voltage tests, set the DUT to generate Test Mode 1 signal. For Distortion test, set the DUT to generate Test Mode 4 signal.
- 4. Connect the Ethernet cable to J490 and the test port of the DUT.
- 5. In the JigMatch dialog box > Test Fixture Compensation group box, selectMeasure.



Figure 21: Test Fixture Compensation in JigMatch

To compensate the linearities of Test Fixture (TC5) using JigMatch, follow the steps given below:

Test Fixture Compensation, Step 2:

- **1.** Use TC5 of the test fixture.
- 2. Make the connections as shown in the following figure.

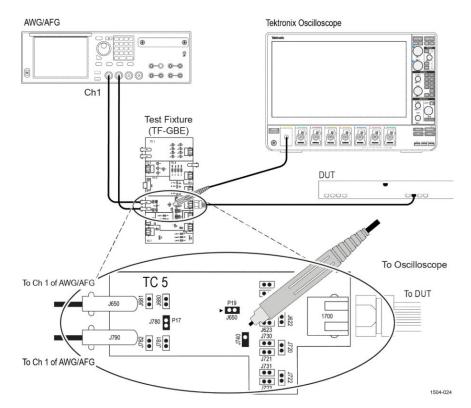


Figure 22: Connection diagram to measure linearities of the Test Fixture using JigMatch

- **3.** For Template, Droop, and Peak Voltage tests, set the DUT to generate Test Mode 1 signal. For Distortion test, set the DUT to generate Test Mode 4 signal.
- 4. Connect the Ethernet cable to J700 and test port of the DUT.
- **5.** Switch **OFF** the Arbitrary Waveform Generator/Arbitrary Function Generator.

**NOTE.** Short the jumpers *J*621, *J*630, *J*623, *J*721, *J*723, *J*680, and *J*781.

**6.** Connect the differential probe to P18 and configured channel of the oscilloscope.

7. In the Jig Match dialog box >under step 2 of Test Fixture Compensation group box, select Measure.

Step 2: Connect DUT to te:	st fixture TC5		
E	xpected Value	Last Measured Value	
Probe PointAmp	500mV	500mV	Measure
Attenuation	1.5	1.5	Default

Figure 23: Test Fixture Compensation in JigMatch

#### Method to set up the Signal Source for Do not use configuration:

In Configuration Panel if the Signal source is selected as *For JigMatch test: AWG/AFG/Scope AFG* is *Do not use*, then the waveform need to be manually loaded in the Signal Source before running the JigMatch Calibration.

Global Settings	Measurements	
Instruments Detect	ed	
Real Time Scope		MSO64 ( GPIB8:: 1::INSTR )
For JigMatch test : AWG/AFG/Scop		Do not use
For Return Loss te	st : AWG/AFG	AWG5202 (TCPIP::134.64.246.111

Figure 24: JigMatch Signal Source selection, with Do not use configuration

To load the waveform follow the steps below:

#### Method to setup the supported AWG For Test Mode 1:

1. Copy the waveform available in Oscilloscope located at C:\Program Files \Tektronix\TekExpress\TekExpress Ethernet\AWG Waveforms \AWG\_Automation\_Files\Template5K.wfm, to the AWG using LAN or USB.

The above mentioned path is applicable for all supported AWG models.

- 2. Set Amplitude on the AWG to 700 mVpp.
- 3. Switch ON the channel and click Play.

we's tests			
	Die Playing		
min Setup Waveform Plug in Sequence Editor Copture/Playt	ack Precompensation Utilities		
		Force Trig A Force Trig B All Outputs C	HT AWG Functions
🕽 Themplate SK 🔹 👾 🚎			Amplitude 200.0 mVpp
			cellast my
and the second			Constant and Anna Anna Anna Anna Anna Anna Anna
	-		<b>eta</b> 1016 - 411
			Amplitude 500.0 mVpp
Bare Continuous -			carliert ov
y nur commune			
anw			
Sample Rate: 1 G	14		

Figure 25: AWG with Test Mode 1 waveform loaded

#### Method to setup the supported AWG For Test Mode 4:

 Copy the waveform available in Oscilloscope located at C:\Program Files \Tektronix\TekExpress\TekExpress Ethernet\AWG Waveforms \AWG\_Automation\_Files\Distortion5K.wfm, to the AWG using LAN or USB.

The above mentioned path is applicable for all supported AWG models.

- 2. Set Amplitude on AWG to 1.35 Vpp.
- 3. Switch ON the channel and click Play.

D AWK05282			
	Playing		
Home Setup Waveform Plug-ins Sequence Editor Capture/Playback Precompensation Utilities			Wa
	Fe	orce Trig A Force Trig B All Outputs Off	AWG Functions
O Channel 1 Distortion5K 🔹 🔆			mplitude 1.350 Vpp
			Offset 0 V
673 mV			
.475 mV			
0 4k 8k 12k 26k 29k			45 K 48 K
Click to assign waveform/sequence      X X			mplitude 500.0 mVpp
8 Run Continuous -			Offset 0 V
o nun comproods -			Crisel VV
250 mV			
-220 mV			
Sample Rate: 1 GS/s			

Figure 26: AWG with Test Mode 4 waveform loaded

#### Method to setup the supported AFG For Test Mode 1:

- 1. Set signal source on both the channels as Sine.
- 2. Set the Frequency on both the channels to 31.25 MHz.
- 3. Set the Amplitude on both the channels to 700 mVpp.
- 4. Set Phase of channel 2 to 180 degrees.
- 5. Switch ON both the channels.

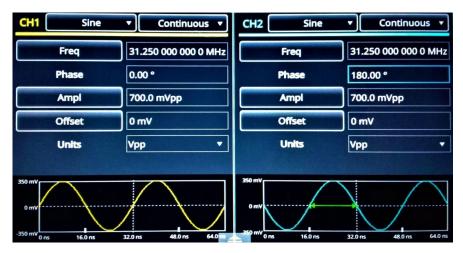


Figure 27: AFG with Test Mode 1 waveform loaded

#### Method to setup the supported AWG For Test Mode 4:

- 1. Set signal source on both the channels as Sine.
- 2. Set the Frequency on both the channels to 20.833 MHz.
- 3. Set the Amplitude on both the channels to 1.35 mVpp.
- 4. Set Phase of channel 2 to 180 degrees.
- 5. Switch ON both the channels.

CH1 Sine	▼ Continuous ▼	CH2 Sine	▼ Continuous ▼
Freq	20.833 000 000 0 MHz	Freq	20.833 000 000 0 MHz
Phase	0.00 °	Phase	180.00 °
Ampl	1.350 Vpp	Ampi	1.350 Vpp
Offset	0 mV	Offset	0 mV
Units	Vpp 🔻	Units	Vpp 🔻
675 mV 0 mV 675 mV 0 ns 240 ns	48.0 ns 72.0 ns 96.0 m	675 mV 0 mV 475 mV 0 ns 240 ns	48.0 ns 72.0 ns 96.0 ns

Figure 28: AFG with Test Mode 4 waveform loaded

# Set preferences tab parameters

Use Preferences tab to set the application action on completion of a measurement.

<b>W</b> TekExpre	ess Ethernet - (Unt	itled)*	Options	<b>≞</b> – ⊗
Setup Status Results Plots	<ul> <li>DUT</li> <li>DUT</li> <li>Test Selection</li> <li>Acquisitions</li> <li>Configuration</li> <li>Preferences</li> </ul>	Number of Runs         Acquire/Analyze each test       2       times         Actions on Test Measurement Failure       On Test Failure, stop and notify me of the failure       Email         On Test Failure, stop and notify me of the failure       Email       Settings         Auto close Warnings and Informations during Sequencing       Auto close after 10       seconds         Auto close Error Messages during Sequencing. Show in Reports       Auto close after 10       seconds	Options	Pause
C	Completed.			

### Table 17: Preferences tab settings

Setting	Description		
Number of Runs			
Acquire/Analyze each test <no> times (not applicable to Custom Tests)</no>	Select to repeat the test run by setting the number of times. By default, it is selected with 1 run.		
Actions on Test Measurement Failure			
On Test Failure, stop and notify me of the failure	Select to stop the test run on Test Failure, and to get notified via email. By default, it is unselected. Click Email Settings to configure.		
Popup Settings	·		
Auto close Warnings and Informations during Sequencing Auto close after <no> Seconds</no>	Select to auto close warnings/informations during sequencing. Set the Auto close time. By default it is unselected.		
Auto close Error Messages during Sequencing. Show in Reports Auto close after <no> Seconds</no>	Select to auto close Error Messages during Sequencing. Set the Auto close time. By default it is unselected.		

# **Status panel**

Status panel overview

The Status panel accesses the Test Status and Log View tabs, which provide status on test acquisition and analysis (Test Status) and a listing of test tasks performed (Log View tab). The application opens the Test Status tab when you start a test run. You can select the Test Status or the Log View tab to view these items while tests are running.

#### Test status view

Test Status Log View			
st Name	Acquisition	Acquire Status	Analysis Status
Template Point A	TemplateA, Without Disturber	Completed	Completed
Template Point B	TemplateB Without Disturber	Completed	Completed
Template Point C	TemplateC_Without_Disturber	Completed	Completed
Template Point D	TemplateD_Without_Disturber	Completed	Completed
Template Point F	TemplateF_Without_Disturber	Completed	Completed
Template Point H	TemplateH_Without_Disturber	in Progress	To be started
Peak Point A	PeakvotageA_Without_Disturber	To be started	To be started
Peak Point B	Peakvoitage8_Without_Disturber	To be started	To be started
Peak Point C	PeakvoltageC_Without_Disturber	To be started	To be started
Peak Point D	Peakvoitage0_Without_Disturber	To be started	To be started
Droop Point G	DroopG_Without_Disturber	To be started	To be started
Droop Point J	DroopJ_Without_Disturber	To be started	To be started
Transmitter Distortion Without TX_TCLK	Distortion_Without_Disturber_Wit hout_TX_TCLK	To be started	To be started
Transmitter Distortion With TX_TCLK	Distortion_Without_Disturber_With h_TX_TCLK	To be started	To be started
Template Point A (D)	TemplateA_With_Disturber	To be started	To be started
Template Point B (D)	TemplateB_With_Disturber	To be started	To be started
Template Point C (D)	TemplateC_Wth_Disturber	To be started	To be started
Template Point D (D)	TemplateD_With_Disturber	To be started	To be started
Template Point F (D)	TemplateF_With_Disturber	To be started	To be started
Template Point H (D)	TemplateH_With_Disturber	To be started	To be started
py-in-motion in pro-	Paulinebased 1986 Pickabas	** La	Water stands

#### Log view

Test Dalas I and the			
Test Status Log View			
	Message History		
05/07/19 2253.49: Executing Tensial 05/07/19 2253.51: Acquiring wavefor 05/07/19 2253.51: Acquiring Twavefor 05/07/19 2253.52: Acquiring Twavefor 05/07/19 2254.04: Acquiring Twavefor 05/07/19 2254.04: Acquiring Twavefor 05/07/19 2254.09: Analyzing for Tem 05/07/19 2254.09: Analyzing for Tem 05/07/19 2254.09: Analyzing for Tem	Similario 2023 2023 2023 2023 2023 2023 2023 2023		¢ >
Auto Scroll	(	Clear Log Save	
V HUID DUIN		Crear Log Save	

Control	Description		
Message History	Lists all executed test operations and timestamp information.		
Auto Scroll	Enables automatic scrolling of the log view as information is added to the log during the test.		
Clear Log	Clears all messages from the log view.		
Save	Saves the log file to a text file. Use the standard Save File window to navigate to and specify the folder and file name to which to save the log text.		

#### Table 18: Status panel Log View controls

See also. *Application panel overview* 

# **Results panel**

# **Results panel overview**

When a test execution is complete, the application automatically opens the **Results** panel to display a summary of test results.

Ov	erall Test Result 🛛 🔮 Pas	S				Preferences	
	Test Name	Details	Pass/Fail	Value	Margin	Units	
	Receiver Return Loss ≢	ReturnLoss_R eceiver 850hm_Run1	🦁 Pass	3.0990	L:3.0990	dB	Ê
	Receiver Return Loss +	ReturnLoss_R eceiver 1000hm_Run	🥑 Pass	11.7726	L:11.7726	dB	11
	Receiver Return Loss +	ReturnLoss_R eceiver 1150hm_Run	🥑 Pass	2.7588	L:2.7588	dB	
	Receiver Return Loss	ReturnLoss_R eceiver 850hm_Run2	🕜 Pass	3.1226	L:3.1226	dB	
	Receiver Return Loss	ReturnLoss_R eceiver 1000hm_Run	🎯 Pass	10.1108	L:10.1108	dB	
	Receiver Return Loss +	ReturnLoss_R eceiver 1150hm_Run	🥑 Pass	3.5099	L:3.5099	dB	
	Receiver Return Loss +	ReturnLoss_R eceiver 850hm_Run3	🥑 Pass	2.1059	L:2.1059	dB	
	Receiver Return Loss +	ReturnLoss_R eceiver 1000hm_Run	🥑 Pass	8.6606	L:8.6606	dB	
	Receiver Return Loss	ReturnLoss_R eceiver 1150hm_Run	🕜 Pass	4.0344	L:4.0344	dB	
	Receiver Return Loss	ReturnLoss_R	Race	3.5779	L:3.5779	dB	~

#### See also. View a report

Application panel overview

**View test-related files** Files related to tests are stored in My TekExpress\Ethernet\. Each test setup in this folder has both a test setup *file* and a test setup *folder*, both with the test setup name.

The test setup file is preceded by the TekExpress icon and usually has no visible file name extension.

Inside the test setup folder is another folder named for the DUT ID used in the test sessions. The default is DUT001.

Inside the DUT001 folder are the session folders and files. Each session also has a folder and file pair, both named for the test session using the naming convention (date)\_(time). Each session file is stored outside its matching session folder:

Each session folder contains image files of any plots generated from running the test session. If you selected to save all waveforms or ran tests using prerecorded waveform files, these are included here.

The first time you run a new, unsaved session, the session files are stored in the Untitled Session folder located at ..\My TekExpress\Ethernet\. When you name and save the session, the files are placed in a folder with the name that you specify. A copy of the test files stay in the Untitled Session folder until you run a new test or until you close the Ethernet application.

See also. File name extensions

# **Plots panel**

Plots panel overview

The Plots panel displays the result as a two-dimensional plot for additional measurement analysis. The plots are displayed only for Return Loss measurements.



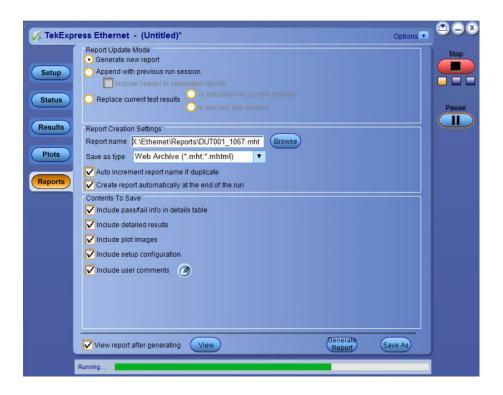
**Toolbar functions in plot windows.** The Plot Toolbar window includes the following functions:

Icon	Functions
	Saves the plot.
Save	
\$	Expands the selected plot area. Left-click and drag the mouse to mark the region on the plot to zoom.
Select & Zoom	
٩	Expands part of the plot (Horizontal and Vertical); the data appears in more detail.
Zoom In	
	Contracts part of the plot (Horizontal and Vertical); the data appears in less detail.
•	
Zoom Out	
	Moves the plot anywhere within the scale.
S.	
Pan	
	Hides the gridlines.
±	
Hide Gridlines	
	Resets the zoom to 100%.
Reset	
	Sets the plot color. Click and select the color in the Color window and click OK. Click in the plot area to apply the color.
Choose Waveform Colors	

Icon	Functions
	Displays or hides the markers
₿.	
Show/Hide Markers	
	Click to undock/dock the plot window.
⇒	
UnDock/Dock	
Select Test	Select the measurement.

# **Reports panel**

**Reports panel overview** Use Reports panel to browse for reports, name and save reports, select test content to include in reports, and select report viewing options.



For information on setting up reports, see *Select report options*. For information on viewing reports, see *View a report*.

#### See also. Application panel overview

**Select report options** Click Reports panel and use the Reports panel controls to select which test result information to include in the report, and the naming conventions to use for the report. For example, always give the report a unique name or select to have the same name increment each time you run a particular test.

Select report options before running a test or when creating and saving test setups. Report settings are included in saved test setups.

In the Reports panel, select from the following report options:

#### **Table 19: Report options**

Setting	Description			
Report Update Mode				
Generate new report	Creates a new report. The report can be in either .mht or .pdf file formats.			
Append with previous run session	Appends the latest test results to the end of the current test results report.			
Include header in appended reports	Select to include header in the appended reports.			
Replace current test in previous run session	Replaces the previous test results with the latest test results. Results from newly added tests are appended to the end of the report.			
Report Creation Settings				
Report name	Displays the name and location from which to open an Ethernet report. The default location is at <i>Wy TekExpress\Ethernet</i> <i>\Untitled Session</i> . The report file in this folder gets overwritten each time you run a test unless you specify a unique name or select to auto increment the report name. Change the report name or location.			
	Do one of the following:			
	In the Report Path field, type over the current folder path and name.			
	Double-click in the Report Path field and then make selections from the popup keyboard and click the Enter button.			
	Be sure to include the entire folder path, the file name, and the file extension. For example: C:\Documents and Settings\your user name\My Documents\My TekExpress\Ethernet\DUT001.mht.			
	<b>NOTE.</b> You cannot set the file location using the Browse button.			
	Open an existing report.			
	Click <b>Browse</b> , locate and select the report file and then click <b>View</b> at the bottom of the panel.			

Setting	Description
Save as type	Saves a report in the specified file type, selected from the drop- down list.
	<b>NOTE.</b> If you select a file type different from the default, be sure to change the report file name extension in the Report Name field to match.
Auto increment report name if duplicate	Sets the application to automatically increment the name of the report file if the application finds a file with the same name as the one being generated. For example: DUT001, DUT002, DUT003. This option is enabled by default.
Create report automatically at the end of the run	Creates report at the end of the run.
Contents To Save	
Include pass/fail info in details table	Includes pass/fail info in the details table of the report.
Include detailed results	Includes detailed results in the report.
Include plot images	Includes plot images in the report.
Include setup configuration	Sets the application to include hardware and software information in the summary box at the top of the report. Information includes: the oscilloscope model and serial number, the oscilloscope firmware version, and software versions for applications used in the measurements.
Margin value in percentage	Select to include the margin value in percentage in the report.
Include user comments	Select to include any comments about the test that you or another user added in the DUT tab of the Setup panel. Comments appear in the Comments section, under the summary box at the beginning of each report.
View report after generating	Automatically opens the report in a Web browser when the test completes. This option is selected by default.
View	Click to view the most current report.
Generate Report	Generates a new report based on the current analysis results.
Save As	Specify a name for the report.

- View a report The application automatically generates a report when test execution is complete and displays the report in your default Web browser (unless you cleared the View **Report After Generating** check box in the Reports panel before running the test). If you cleared this check box, or to view a different test report, do the following:
  - 1. Click the **Reports** button.
  - 2. Click the Browse button and locate and select the report file to view.
  - 3. In the Reports panel, click View.

For information on changing the file type, file name, and other report options, see *Select report options*.

#### **Report contents** A report shows detailed results and plots, as set in the Reports panel.

<b>Tek</b> t	roni	X®		Express Ether			
Setup Information							
DUT ID		DUT001		Scope Information	MSO 54	4, C012701	
Date/Time		2019-05-03 06:37:23		Scope F/W Version	1.15.4	8.6297	
Device Type		Ethernet		Return Loss Signal Generato	r AWG5	202	
TekExpress Ethernel	t Version	1.0.1.616		Jigmatch Signal Generator	AWG5	202	
TekExpress Framew	ork Version	4.10.0.35		DATA Probe Model	TDP35	500	
Execution Mode		Live		DATA Probe Serial Number	B0122	B012249	
Compliance Mode		True		MCLK Probe Model		TDP3500	
Overall Test Result		Pass		MCLK Probe Serial Number		Q100110	
Overall Execution Ti	me	0:09:08					
DUT COMMENT:	General comm	ient					
Test Name Summary	Table						
Receiver Return Loss				Pass			
Receiver Return Loss							
Frequency	Spec. Value	850hm	1000hm	1150hm	Result	Comments	
1 MHz	-16dB	-21.38dB	-48.68dB	-23.53dB	Pass		
10MHz	-16dB	-23.53dB	-28.66dB	-21.23dB	Pass		
20MHz	-16dB	-20.5dB	-30.81dB	-21.59dB	Pass		
30MHz	-16dB	-21.89dB	-32.83dB	-22.78dB	Pass		
40MHz	-16dB	-19.4dB	-30.48dB	-24.37dB	Pass		
50MHz	-14.08dB	-19.77dB	-33.54dB	-25.56dB	Pass		
60MHz	-12.5dB	-20.74dB	-36.89dB	-24.98dB	Pass		

Setup configuration information

The summary box at the beginning of the report lists setup configuration information. This information includes the oscilloscope model and serial number, optical module model and serial number, and software version numbers of all associated applications.

To exclude this information from a report, clear the **Include Setup Configuration** check box in the Reports panel before running the test.

User comments

If you selected to include comments in the test report, any comments you added in the DUT tab are shown at the top of the report. See also. *Results panel overview View test-related files* 

# **Running tests**

1000BASE-T connection diagram

Click **Setup** > **Test Selection** > **Preview** to view the equipment setup diagram(s).

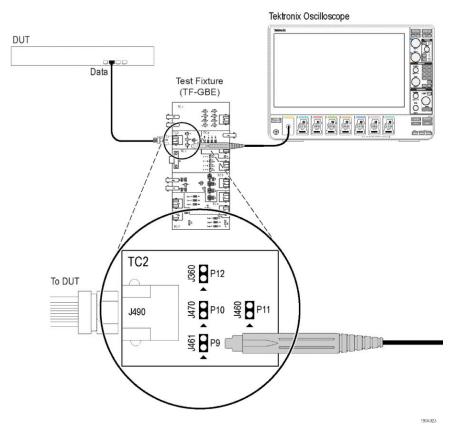


Figure 29: 1000BASE-T Template, Peak Volt, and Droop (Without Disturber)

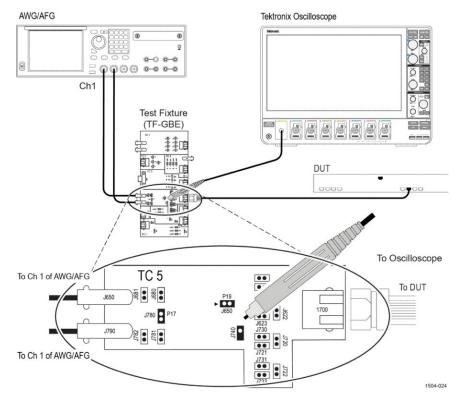


Figure 30: 1000BASE-T Template, Peak Volt, and Droop (With Disturber)

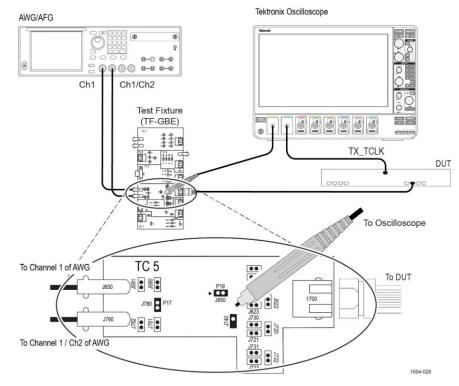


Figure 31: Distortion with Disturber with Clock

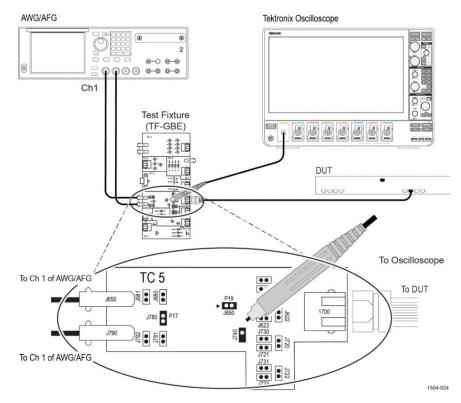


Figure 32: Distortion with Disturber without Clock

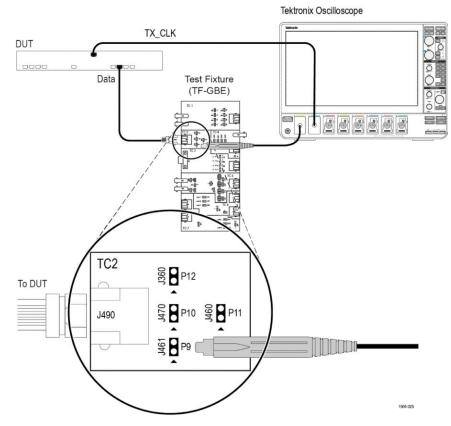


Figure 33: Distortion without Disturber with Clock

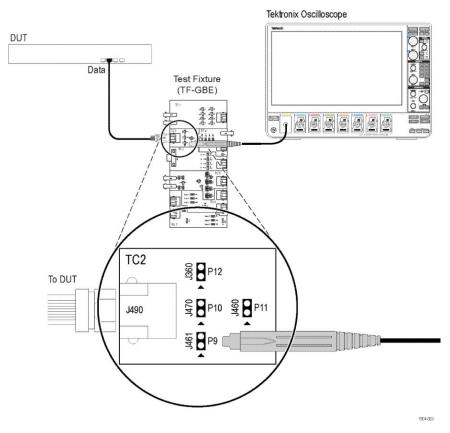


Figure 34: Distortion without Disturber without Clock

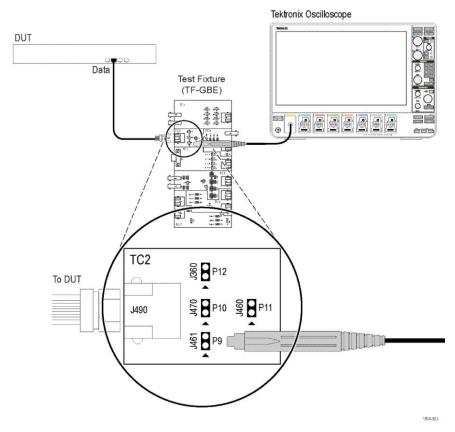
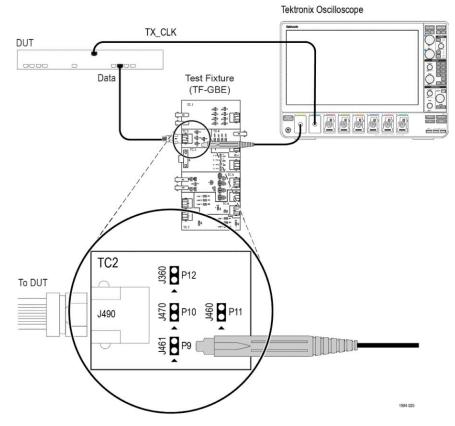


Figure 35: Master and Slave Jitter without Clock





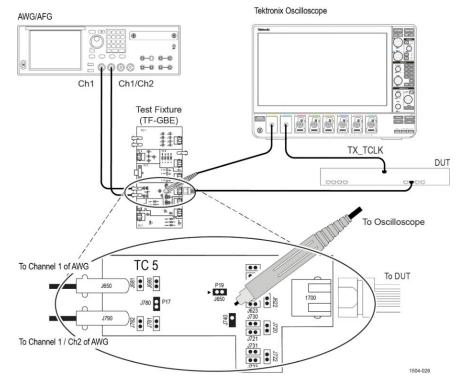


Figure 37: Master Filtered with Clock - Connection 2

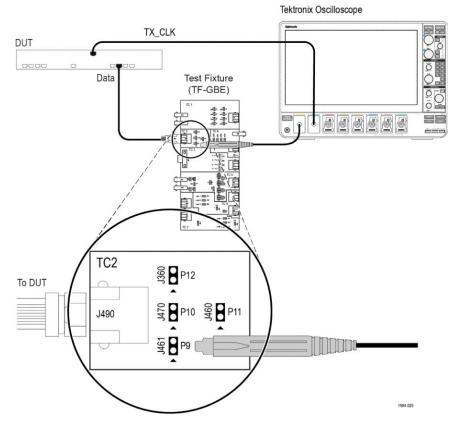


Figure 38: Master Unfiltered with Clock

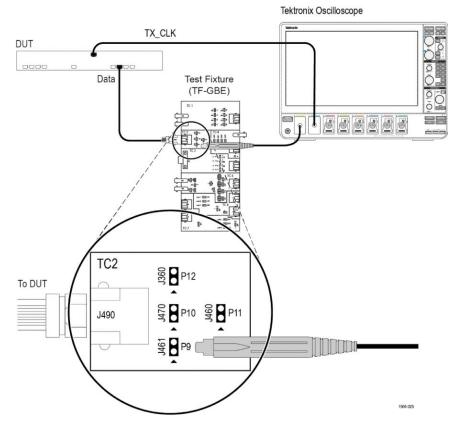


Figure 39: Slave Filtered with Clock - Connection 1

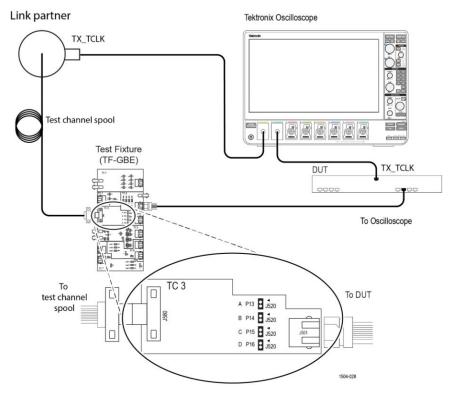


Figure 40: Slave Filtered with Clock - Connection 2

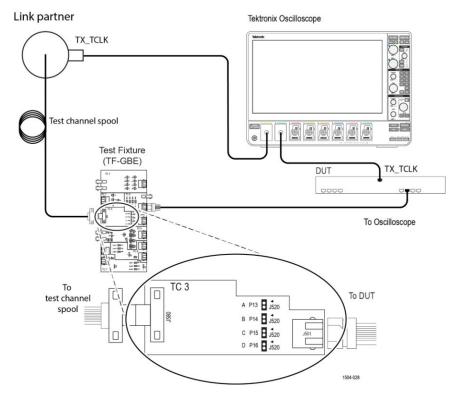


Figure 41: Slave Unfiltered with Clock

Tektronix Oscilloscope

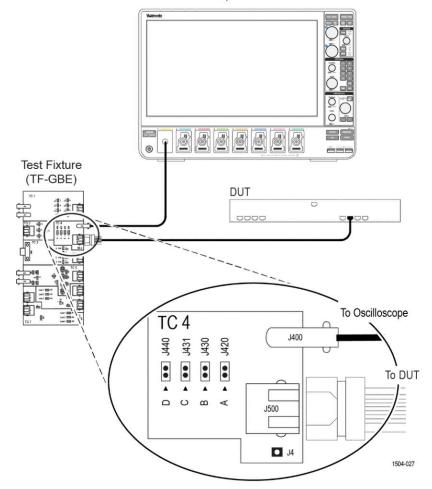


Figure 42: 1000BASE-T CM Voltage

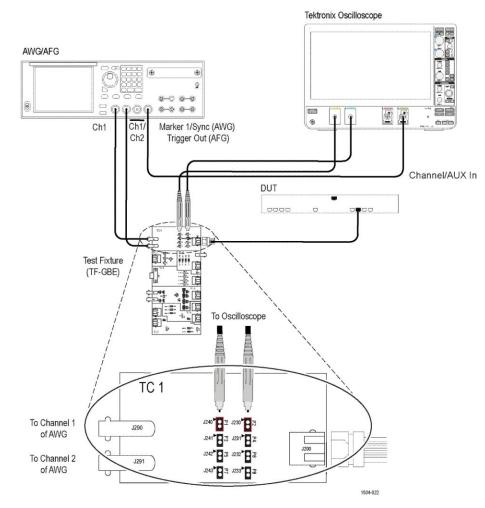
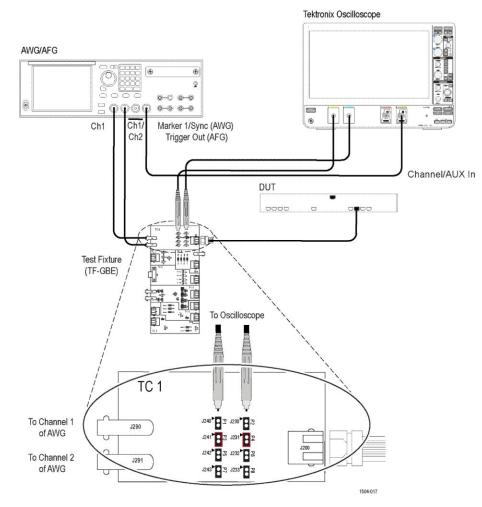
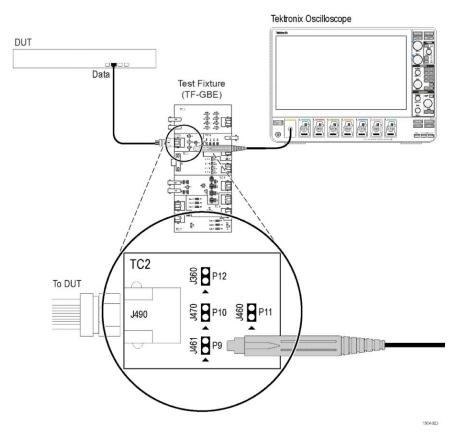


Figure 43: 1000BASE-T Transmitter Return Loss





# 100BASE-T connection diagram



Click **Setup** > **Test Selection** > **Preview** to view the equipment setup diagram(s).

Figure 45: 100BASE-T connection diagram for all tests except Return Loss

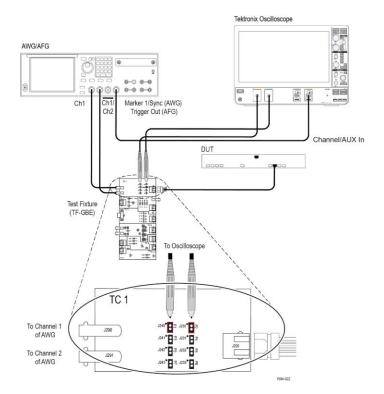


Figure 46: 100BASE-T Transmitter Return Loss

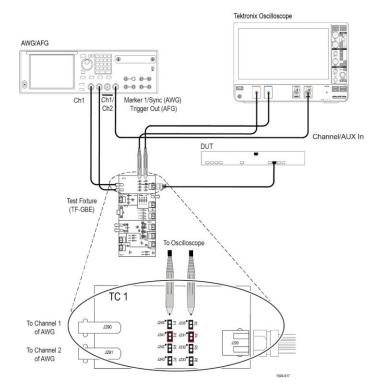
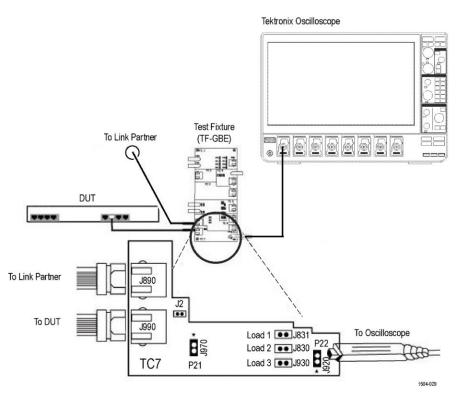


Figure 47: 100BASE-T Receiver Return Loss

# **10BASE-T** connection diagram





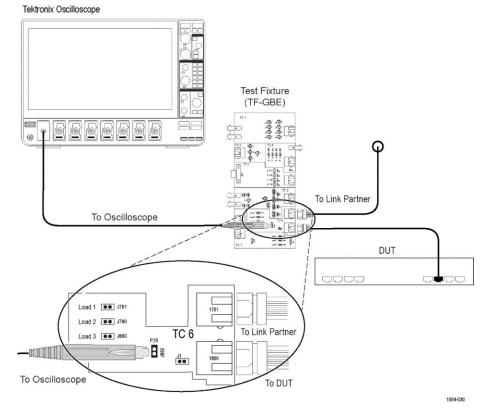


Figure 49: 10BASE-T TP\_IDL Load Without TPM, Jitter, Link Pulse Load Without TPM, Harmonic, and Link Pulse Timing Without TPM , and Differential Voltage

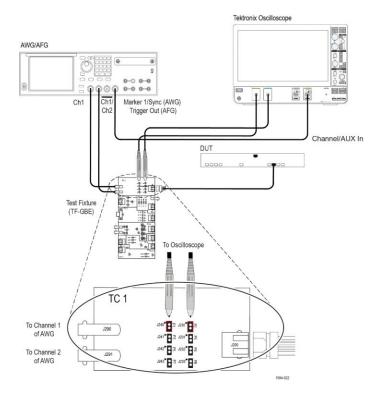
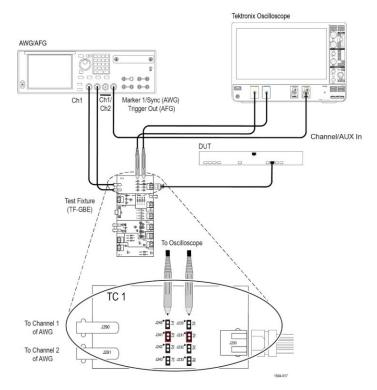


Figure 50: 10BASE-T Transmitter Return Loss







# Prerequisite

Compensate the signal path	Use the following procedure to compensate the internal signal acquisition path. Perform this procedure if the ambient temperature has changed more than 5 °C (9 °F) since you performed the last signal path compensation. Perform the signal path compensation once a week. Failure to do so may result in the instrument not meeting warranted performance levels.
	1. Power on and wait for the instrument to complete its warm up period before continuing with this procedure.
	2. Disconnect any probes you have connected to the input channels.
	<b>3.</b> Set the instrument to Menu mode.
	4. Select Instrument Calibration from the Utilities menu.
	5. Note any instructions that appear in the resulting control window.
	<b>6.</b> Click Run SPC to begin the procedure. The procedure may take several minutes to complete.
	7. Verify that the Status changes to Pass after the procedure is complete. If the Calibration Status field indicates anything other than Compensated, see Signal Path Compensation Status for information on the readout and recommended action.
	<b>NOTE.</b> When making measurements at vertical scale settings less than or equal to 5 mV, you should perform the signal path compensation at least once a week. Failure to do so may result in the instrument not meeting warranted performance levels at those volts/div settings.

# Running tests

	<i>Select tests, set acquisition parameters, set configuration parameters, set preferences parameters,</i> and click <b>Start</b> to run the tests. While tests are running, you cannot access the Setup or Reports panels. To monitor the test progress, switch between the Status panel and the Results panel.
	While the tests are running, other applications may display windows in the background. The TekScope application takes precedence over other applications, but you can switch to other applications by using <b>Alt</b> + <b>Tab</b> key combination. To keep the TekExpress Ethernet application on top, select <b>Keep On Top</b> from the TekExpress Options menu.
	The application displays report when the tests execution is complete.
Prerun checklist	1. Make sure that the instruments are warmed up (approximately 20 minutes) and stabilized.
	<ol> <li>Perform compensation: In the oscilloscope main menu, select Utilities &gt; Instrument Compensation. Click Help in the compensation window for steps to perform instrument compensation.</li> </ol>
View test results	
	When a test completes, the application switches to the <i>Results panel</i> , which shows a summary of test results.
	Each test result occupies a row in the Results table. By default, results are displayed in summary format, with the measurement details collapsed. You can change the view in the following ways:
	<ul> <li>To view the results grouped by lane, test, or data rate, select the corresponding item from the Preferences menu.</li> </ul>
	<ul> <li>To expand all tests listed, select View Results Details from the Preferences menu.</li> </ul>
	• To expand and collapse tests, use the plus and minus buttons to the left of the test rows.
	<ul> <li>To collapse all expanded tests, select Preferences &gt; View Results Summary.</li> </ul>
	<ul> <li>To enable or disable the wordwrap feature, select Preferences &gt; Enable Wordwrap.</li> </ul>
	• To expand the width of a column, place the cursor over the vertical line that separates the column from the one to the right. When the cursor changes to a double-ended arrow, hold down the mouse button and drag the column to the desired width.

- To sort the test information by column, click the column head. When sorted in ascending order, a small up arrow is displayed. When sorted in descending order, a small down arrow is displayed.
- To clear all test results displayed, click **Clear** (

See Also View a report

# Saving and recalling test setup

#### Test setup files overview

Saved test setup information (such as the selected oscilloscope, general parameters, acquisition parameters, measurement limits, waveforms (if applicable), and other configuration settings) are saved under the setup name at **X:\Ethernet**.

Use test setups to:

- Run a new session, acquiring live waveforms, using a saved test configuration.
- Create a new test setup using an existing one.
- View all the information associated with a saved test, including the log file, the history of the test status as it executed, and the results summary.
- Run a saved test using saved waveforms.

See also Save a test setup Open (load) a saved test setup

#### Save a test setup

You can save a test setup before or after running a test. You can create a test setup from *already created test setup*, or using *default test setup*. When you select the default test setup, the parameters are set to the application's default value.

Select **Options > Save Test Setup** to save the opened setup.

Select **Options > Save Test Setup As** to save the setup with different name.

#### Open (load) a saved test setup

To Open (load) a saved test setup, do the following:

- 1. Select **Options > Open Test Setup**.
- 2. Select the setup from the list and click **Open**. Setup files are located at **X**: \**Ethernet**\.

See alsoAbout test setupsCreate a test setup using an existing oneCreate a test setup from default settings

#### Create a test setup from default settings

To create a test setup using default settings, follow the steps:

- 1. Select **Options > Default Test Setup**. For default test setup, the parameters are set to the application's default value.
- 2. Click application *Setup* and set the parameters.
- 3. Click application *Reports* and set the report options.
- 4. Optional: Click **Start** to run the test and verify that it runs correctly and captures the specified test information and reports. If it does not, then edit the parameters and repeat this step until the test runs to your satisfaction.
- 5. Select **Options > Save Test Setup**. Enter the file name and click Save. The application saves the file to X:\Ethernet\<*session\_name*>.

#### Create a test setup using an existing one

To create a test setup using an existing one, follow the steps:

- 1. Select Options > Open Test Setup.
- 2. Select a setup from the list and then click **Open**.
- 3. Click application *Setup* and modify the parameters.
- 4. Click application *Reports* and modify the report options.
- 5. Select Options > Save Test Setup As.
- 6. Enter test setup name, and click Save.

# **SCPI Commands**

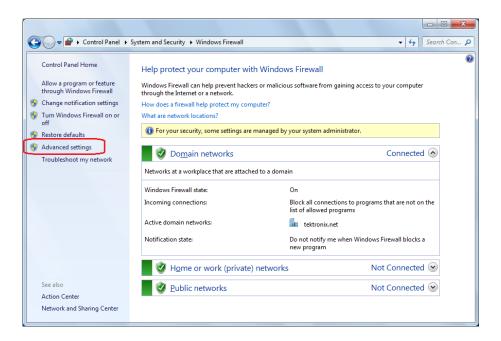
#### About SCPI command

You can use Standard Commands for Programmable Instruments (SCPI) to communicate with the TekExpress application.

#### Socket configuration for SCPI commands

This section describes the steps for TCPIP socket configuration and TekVISA configuration to execute the SCPI commands.

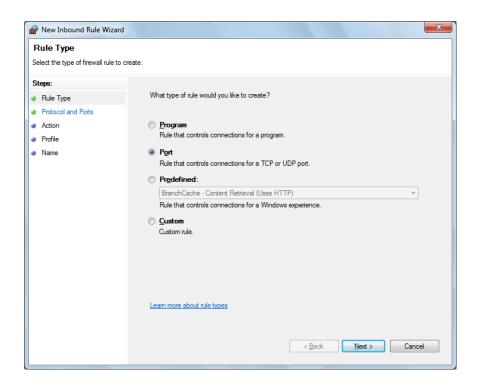
**TCPIP socket**<br/>configuration1. Click Start > Control Panel > System and Security > Windows Firewall ><br/>Advanced settings.



2. In Windows Firewall with Advanced Security menu, select Windows Firewall with Advanced Security on Local Computer > Inbound Rules and click New Rule...

Windows Firewall with Advanced Ele <u>A</u> ction <u>Vi</u> ew <u>H</u> elp	Security							×
Windows Firewall with Advance	Inbound Rules						Actions	-
🔣 Inbound Rules	Name		Group	Profile	Enabled	Action ^	Inbound Rules	
🔀 Outbound Rules	Nume		oroup	Tronic	chabica		New Rule	
Monitoring						E	Filter by Profile	
							Filter by State	_
							Filter by Group	
							View	
							Q Refresh	
							Export List	
							👔 Help	
							Tektronix VISA Call Monitor	
							Disable Rule	
							of Cut	
							Сору	
							🗙 Delete	
							Properties	
							👔 Help	
						-		
• III •	•	m				•		

- 3. In New Inbound Rule Wizard menu
  - a. Select Port and click Next.



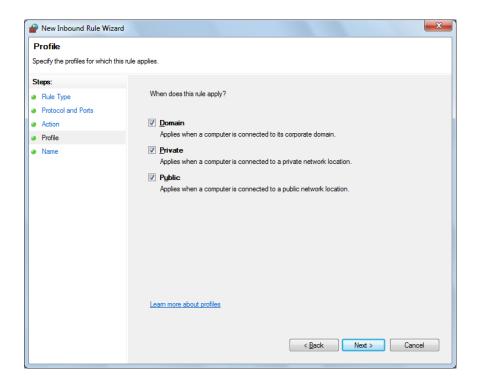
**b.** Select **TCP** as rule apply and enter 5000 for **Specific local ports** and click **Next**.

Prev Inbound Rule Wizard		<b>x</b>			
Protocol and Ports					
Specify the protocols and ports to which this rule applies.					
Steps:					
Rule Type	Does this rule apply to TCP or UDF	??			
Protocol and Ports	<u>Т</u> СР				
<ul> <li>Action</li> </ul>	© <u>U</u> DP				
Profile					
<ul> <li>Name</li> </ul>	Does this rule apply to all local port	s or specific local ports?			
	All local ports				
	Specific local ports:	5000			
		Example: 80, 443, 5000-5010			
	Learn more about protocol and por	ts			
		-			
		< Back Next > Cancel			

c. Select Allow the connection and click Next.

🔗 New Inbound Rule Wizar	d	×
Action Specify the action to be taken	when a connection matches the conditions specified in the rule.	
Specify the action to be taken of Steps: Protocol and Ports Action Profile Name	<ul> <li>when a connection matches the conditions specified in the rule.</li> <li>What action should be taken when a connection matches the specified conditions?</li> <li><b>Allow the connection</b> This includes connections that are protected with IPsec as well as those are not. </li> <li><b>Allow the gonnection if it is secure</b> This includes only connections that have been authenticated by using IPsec. Connections will be secured using the settings in IPsec properties and rules in the Connection Security Rule node. <b>Customize</b> </li> <li><b>Block the connection</b> Leam more about actions</li></ul>	
	< Back Next > Canc	el

d. Select Domain, Private, Public and click Next.



e. Enter Name, Description (optional), and click Finish.

Name Specify the name and description of		
	this rule.	
Steps:		
Rule Type Protocol and Ports		
Action	Name:	
Profile	Tek Express	
Name	Toresprose	
	Description (optional):	
	< <u>B</u> ack	Finish Cancel

4. Check whether the Rule name is displayed in Windows Firewall with Advanced Security menu > Inbound Rules.

Windows Firewall with Advanced	Security						
Eile Action View Help							
🗢 🐟 🔰 🖬 🔒 📓 🗖							
Pindows Firewall with Advance	Inbound Rules						Actions
Inbound Rules Outbound Rules	Name	Group	Profile	Enabled	Action	^	Inbound Rules 🔺
Connection Security Rules	TekExpress		All	Yes	Allow		🗱 New Rule
Monitoring							🍸 Filter by Profile 🕨 🕨
							Tilter by State
							Tilter by Group
							View 🕨
							Q Refresh
							Export List
							👔 Help
							TekExpress
							Disable Rule
							🤏 Cut
							Сору
							🗙 Delete
							Properties
							Help
						Ε	
						-	
<	< III				•		
			_				

# TekVISA configuration 1. Click Start > All Programs > TekVISA > OpenChoice Instrument Manager.

OpenChoice Instrument Manager	
Eile Edit Help	
Instruments	Applications and Utilities
	OpenChoice Call Monitor OpenChoice Talker Liste
Last Updated: 12/17/2015 10:34 PM	
Instrument List Update Search Criteria Update Search Criteria	Start Application or Utility

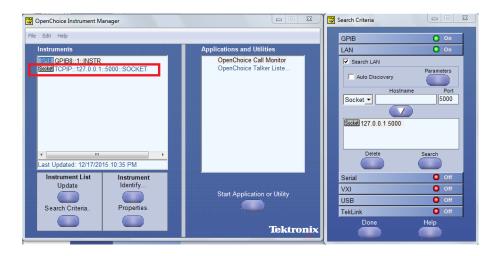
2. Click Search Criteria. In Search Criteria menu, click LAN to Turn-on. Select Socket from the drop-down list, enter the IP address of the

TekExpress device in **Hostname** and type **Port** as 5000. Click to configure the IP address with Port.

Enter the Hostname as 127.0.0.1 if the TekVISA and TekExpress application are in the same system, else enter the IP address of the TekExpress application system.

VISA VISA	Search Criteria	
	GPIB	On
	LAN	On
	Search LAN	
	Auto Discovery	Parameters
	Hostname	Port
	Socket -	5000
	Socket 127.0.0.1 5000	
	Delete	Search
	Serial	Off
	VXI	Off
	USB	Off
	TekLink	Off
	Done	Help

**3.** Click **Search** to setup the TCPIP connection with the host. Check whether the TCPIP host name is displayed in **OpenChoice Instrument Manager** > **Instruments**.



4. Double-click **OpenChoice Talker Listener** and enter the Command \*IDN? in command entry field and click **Query**. Check that the Operation is successful and Talker Listener Readout displays the Command / Data.

OpenChoice Talker Listener     Ele Edit Iools Help	
Instruments DEFE GPIBs-11:INSTR EXCEPTCPIP: 127.0.0.1-5000:SOCKET	Enter Command or Script IDN? Write Read Query Hex Entry Enabled Command / Script History - IDN?
Last Updated 12/17/2015 10:36 PM Update Reset Communications	AutoQuery - False ; Term Char - LF ;
Talker Listener Readout:	Display As: 💌 ASCII Only 🌑 Hex and ASCII
Date / Time         Duration         Source           12/17/2015 10         0.0170s         VISA           12/17/2015 10         0.0070s         MSOS4           12/17/2015 10         0.00775s         TCPIP	Command / Data Command Type TCPIP::127.0.0.1::5000::SOCKET Open Session 'UDN? Write TekExpress Read
Operation Successful	

# **TEKEXP:\*IDN?**

This command queries the active TekExpress application name running on the oscilloscope.

Syntax	TEKEXP:*IDN?\n
Inputs	NA
Outputs	Returns active TekExpress application name running on the oscilloscope.
C?	
	This command queries the execution status of the last executed command.
Syntax	TEKEXP:*OPC?\n

#### **TEKEXP:\*OPC**

Inputs NA

Outputs 0 - last command execution is not complete 1 - last command execution is complete

## TEKEXP:ACQUIRE\_MODE

This command sets the acquire mode as live or pre-recorded.

**Syntax** TEKEXP:ACQUIRE\_MODE {LIVE | PRE-RECORDED}\n

- **Inputs** {LIVE | PRE-RECORDED}
- Outputs NA

#### TEKEXP:ACQUIRE\_MODE?

This command queries the acquire mode type.

Syntax TEKEXP:ACQUIRE\_MODE?\n

Inputs NA

**Outputs** {LIVE | PRE-RECORDED}

# **TEKEXP:EXPORT**

This command returns all the bytes of data to the specified file.

Syntax	Outputs
TEKEXP:EXPORT REPORT\n	Returns the report file in bytes
TEKEXP:EXPORT WFM," <filename>"\n</filename>	Returns the specified waveform file in bytes
TEKEXP:EXPORT IMAGE," <filename>"\n</filename>	Returns the specified image file in bytes

Inputs FileName - Specifies the file name

## **TEKEXP:INFO?**

This command queries the information about the file(s).

Syntax	Outputs
TEKEXP:INFO? REPORT\n	<reportfilesize>,"<reportfilename.mht>"</reportfilename.mht></reportfilesize>
TEKEXP:INFO? WFM	<wfmfile1size>,"<wfmfilename1.wfm>";<wfmfile2size>,"<wfmfilena me2.wfm="">";</wfmfilena></wfmfile2size></wfmfilename1.wfm></wfmfile1size>
TEKEXP:INFO? IMAGE\n	<image1filesize>,"<image1filename>";<image2filesize>,"<image2filename>";</image2filename></image2filesize></image1filename></image1filesize>

## **TEKEXP:INSTRUMENT**

	This command sets the value for the selected instrument type.
Syntax	TEKEXP:INSTRUMENT " <instrumenttype>",<value>"\n</value></instrumenttype>
Inputs	InstrumentType Value
•	<b>TIP.</b> Check Command parameters list section for InstrumentType and Value parameters.
Outputs	NA

#### **TEKEXP:INSTRUMENT?**

This command queries the instrument selected for the specified instrument type.

Syntax TEKEXP:INSTRUMENT? "<InstrumentType>"\n

Inputs InstrumentType



**TIP.** Check Command parameters list section for InstrumentType parameters.

**Outputs** Returns the instrument selected for the specified instrument type

### **TEKEXP:LASTERROR?**

This command queries the last error string occurred for the current TCP session. If there are no errors since startup, or since the last call to TEKEXP:LASTERROR?\n, this command returns an empty string.

Syntax TEKEXP:LASTERROR?\n

Inputs NA

Outputs <string>

### **TEKEXP:LIST?**

This command queries the list of available device, suite, test, version or instrument.

Syntax	Outputs
TEKEXP:LIST? DEVICE\n	Returns the list of available device(s) as comma separated values.
TEKEXP:LIST? SUITE\n	Returns the list of available suite(s) as comma separated values.
TEKEXP:LIST? TEST\n	Returns the list of available test(s) as comma separated values.
TEKEXP:LIST? VERSION\n	Returns the list of available version(s) as comma separated values.
TEKEXP:LIST? INSTRUMENT," <instrumenttype>"\n</instrumenttype>	Returns the list of available instruments' for the given Instrument type as comma separated values.

**NOTE.** This command returns the list of items within double quotes (""). Iterate the receive procedure until the list ends with double quotes otherwise the next query commands won't work as expected.

Inputs	InstrumentType	
<b>(</b>	<b>TIP.</b> Check Command parameters list section for InstrumentType parameters.	
TEKEXP:MODE		
	This command sets the execution mode as compliance or user defined.	
Syntax	TEKEXP:MODE {COMPLIANCE   USER-DEFINED}\n	
Inputs	{COMPLIANCE   USER-DEFINED}	
Outputs	NA	
TEKEXP:MODE?		
This command queries the execution mode type.		
Syntax	TEKEXP:MODE?\n	
Inputs	NA	
Outputs		

TEKEXP:POPUP		
	This command sets the response to the active popup shown in the application.	
Syntax	TEKEXP:POPUP " <popupresponse>"\n</popupresponse>	
Inputs	PopupResponse	
Outputs	NA	
TEKEXP:POPUP?		
	This command queries the active popup information shown in the application.	
Syntax	TEKEXP:POPUP?\n	
Inputs	NA	
Outputs	Returns the active popup information in the application.	

TEKEXP:REPORT	
	This command generates the report for the current session.
Syntax	TEKEXP:REPORT GENERATE\n
Inputs	GENERATE
Outputs	NA
TEKEXP:REPORT?	
	This command queries the queried header field value in the report.
Syntax	TEKEXP:REPORT? " <headerfield>"\n</headerfield>
Inputs	HeaderField - Specifies to return the measured value for the indicated test.
<b>(</b>	TIP. Check Report for HeaderField parameters.
Outputs	Returns the queried header field value in the report

## TEKEXP:RESULT?

This command queries the result available in report summary/details table.

Syntax	Outputs
TEKEXP:RESULT? " <testname>"\n</testname>	Return Pass/Fail status of the test.
TEKEXP:RESULT? " <testname>","<columnname>"\n</columnname></testname>	Returns all the row values of the specified column for the test.
TEKEXP:RESULT? " <testname>","<columnname>",<rownumber &gt;\n</rownumber </columnname></testname>	Returns the column value for the specified row number <sup>1</sup>

**Inputs** TestName - Specifies the name of the test for which to obtain the test result value.

ColumnName - Specifies the column name for the measurement

RowNumber - Specifies the row number of the measurement



**TIP.** Check **Results** panel for TestName, ColumnName, and RowNumber parameters.

<sup>&</sup>lt;sup>1</sup> Row number starts from zero.

### TEKEXP:SELECT

This command selects the device, suite, version, or test.

**Syntax** TEKEXP:SELECT <string1>,<string2>,<string4>\n TEKEXP:SELECT TEST,<string3>,<string4>\n

Inputs <string1> = {DEVICE | SUITE | VERSION}
<string2> = {DeviceName | SuiteName | VersionName}
<string3> = {"<TestName>"| ALL| REQUIRED }
<string4> = {TRUE | FALSE}



**TIP.** Check Command parameters list section for DeviceName, SuiteName, VersionName, and TestName parameters.

Outputs NA

### **TEKEXP:SELECT?**

This command queries the name of the selected device, suite, version, or test.

**Syntax** TEKEXP:SELECT? {DEVICE | SUITE | TEST | VERSION}\n

Inputs {DEVICE | SUITE | TEST | VERSION}

**Outputs** Returns the name of the selected device, suite, version, or test.

### **TEKEXP:SETUP**

This command sets the value of the current setup.

Syntax	Outputs
TEKEXP:SETUP DEFAULT\n	Restore to default Setup
TEKEXP:SETUP OPEN," <sessionname>"\n</sessionname>	Open the session
TEKEXP:SETUP SAVE\n	Saves the already existing modified session
TEKEXP:SETUP SAVE," <sessionname>"\n</sessionname>	Save the session

Inputs SessionName - Th	e name of the session
-------------------------	-----------------------

### **TEKEXP:STATE**

This command sets the execution state of the application.

Syntax TEKEXP:STATE {RUN | STOP | PAUSE | RESUME}\n

Inputs {RUN | STOP | PAUSE | RESUME}

Outputs NA

### **TEKEXP:STATE?**

This command queries the current setup state.

Syntax	Outputs
TEKEXP:STATE?	RUNNING   PAUSED   WAIT   ERROR   READY
TEKEXP:STATE? SETUP	SAVED   NOT_SAVED

### **TEKEXP:VALUE**

This command sets the value of parameters of type General, Acquire, Analyze, or DUTID.

Syntax TEKEXP:VALUE GENERAL,"<ParameterName>","<Value>"\n

TEKEXP:VALUE ACQUIRE,"<TestName>","<AcquireType>", "<ParameterName>","<Value>"\n

TEKEXP:VALUE ANALYZE,"<TestName>","<ParameterName>"."<Value>" \n

TEKEXP:VALUE DUTID,"<Value>"\n

TEKEXP:VALUE VERBOSE, {TRUE | FALSE}\n

TEKEXP:VALUE

WFMFILE,<Test\_Name>,<Aquire\_Type>,<FilesName1\$FileName2>\n

Inputs ParameterName - Specifies the parameter name TestName - Specifies the test name AcquireType - Specifies the acquire type Value - Specifies the value to set FilesName1\$FileName2 - Specifies the waveform file name TRUE - Pop-ups are enabled FALSE - Pop-ups are disabled

(**†** 

**TIP.** Check Command parameters list section for ParameterName, AcquireType, and Value parameters.

Outputs NA

## **TEKEXP:VALUE?**

This command queries the value of the parameter for type General, Acquire, Analyze, or DUTID.

Syntax	Outputs
TEKEXP:VALUE? GENERAL," <parametername>"\n</parametername>	Returns the value of Parameter for type GENERAL
TEKEXP:VALUE? ACQUIRE," <testname>", "<acquiretype>","<parametername>"\n</parametername></acquiretype></testname>	Returns the value of Parameter for type ACQUIRE
TEKEXP:VALUE? ANALYZE, " <testname>","<parametername>"\n</parametername></testname>	Returns the value of Parameter for type ANALYZE
TEKEXP:VALUE? DUTID\n	Returns the DUTID value
TEKEXP:VALUE? WFMFILE, <test_name>,<aquire_type>\n</aquire_type></test_name>	Returns the waveform file name
TEKEXP:VALUE? VERBOSE	Returns the verbose mode type

Inputs ParameterName - Specifies the parameter name

TestName - Specifies the test name

AcquireType - Specifies the acquire type

TRUE - Pop-ups are enabled

FALSE - Pop-ups are disabled



**TIP.** Check Command parameters list section for ParameterName and AcquireType parameters.

Outputs Returns the value of Parameter for type GENERAL | ACQUIRE | ANALYZE | DUTID.

## **Command parameters**

This section provides the parameters list for the SCPI commands.

#### Table 20: ParameterName and Value for DUT tab

Parameters	Description
DUT ID	Specifies the value parameters For DUTID, valid value is: Comment
Acquiremode	Specifies the acquire mode parameters <ul> <li>Acquire live waveforms</li> <li>Use pre-recorded waveform files</li> </ul>
Suite	<ul> <li>1000BASE-T</li> <li>100BASE-T</li> <li>10BASE-T</li> </ul>

Parameters	Description
Test Measurements for 1000BASE-T	Specifies the test measurement name. Without Disturber
	TemplateA_Without_Disturber
	TemplateB_Without_Disturber
	TemplateC_Without_Disturber
	TemplateD_Without_Disturber
	TemplateF_Without_Disturber
	TemplateH_Without_Disturber
	PeakvoltageA_Without_Disturber
	PeakvoltageB_Without_Disturber
	PeakvoltageC_Without_Disturber
	PeakvoltageD_Without_Disturber
	DroopG_Without_Disturber
	DroopJ_Without_Disturber
	<ul> <li>Transmitter Distrortion</li> </ul>
	Distortion_Without_Disturber_With_TX_TCLK
	Distortion_Without_Disturber_Without_TX_TCLK
	With Disturber
	TemplateA_With_Disturber
	TemplateB_With_Disturber
	TemplateC_With_Disturber
	TemplateD_With_Disturber
	TemplateF_With_Disturber
	TemplateH_With_Disturber
	PeakvoltageA_With_Disturber
	PeakvoltageB_With_Disturber
	PeakvoltageC_With_Disturber
	PeakvoltageD_With_Disturber
	DroopG_With_Disturber
	DroopJ_With_Disturber
	<ul> <li>Transmitter Distrortion</li> </ul>
	Distortion_With_Disturber_With_TX_TCLK

### Table 21: ParameterName and Value for Test Selection tab

Parameters	Description
	Distortion_With_Disturber_Without_TX_TCLK
	Transmitter Jitter
	MasterFiltered_Jitter_Without_TX_TCLK
	MasterUnfiltered_Jitter_Without_TX_TCLK
	SlaveFiltered_Jitter_Without_TX_TCLK
	SlaveUnfiltered_Jitter_Without_TX_TCLK
	MasterFiltered_Jitter_With_TX_TCLK
	MasterUnfiltered_Jitter_With_TX_TCLK_TCLK
	SlaveFiltered_Jitter_With_TX_TCLK
	SlaveUnfiltered_Jitter_With_TX_TCLK
	ReturnLoss_Transmitter CM Voltage
Test Measurements for 100BASE-T	Specifies the test measurement name.
	AOI_Template
	Fall_Time_Pos
	Fall_Time_Neg
	Rise_Time_Pos
	Rise_Time_Neg
	RF_Symmetry_Pos
	RF_Symmetry_Neg
	Overshoot_Pos
	Overshoot_Neg
	Differential_Output_Voltage_Pos
	Differential_Output_Voltage_Neg
	Amplitude_Symmetry
	= Jitter
	Duty Cycle Distortion
	ReturnLoss_Transmitter
	ReturnLoss_Receiver

Parameters	Description
Fest Measurements for 10BASE-T	Specifies the test measurement name.
	Link Pulse
	Link Pulse Load1 With Twisted Pair cable
	Link Pulse Load2 With Twisted Pair cable
	Link Pulse Load3 With Twisted Pair cable
	Link Pulse Load1 Without Twisted Pair cable
	<ul> <li>Link Pulse Load2 Without Twisted Pair cable</li> </ul>
	Link Pulse Load3 Without Twisted Pair cable
	Link Pulse Timing
	Link Pulse Timing Load1 With Twisted Pair cable
	Link Pulse Timing Load2 With Twisted Pair cable
	<ul> <li>Link Pulse Timing Load3 With Twisted Pair cable</li> </ul>
	Link Pulse Timing Load1 Without Twisted Pair cable
	<ul> <li>Link Pulse Timing Load2 Without Twisted Pair cable</li> </ul>
	<ul> <li>Link Pulse Timing Load3 Without Twisted Pair cable</li> </ul>
	Differential Voltage
	TP_IDL
	TP_IDL Load1 With Twisted Pair cable
	TP_IDL Load2 With Twisted Pair cable
	TP_IDL Load3 With Twisted Pair cable
	TP_IDL Load1 Without Twisted Pair cable
	TP_IDL Load2 Without Twisted Pair cable
	TP_IDL Load3 Without Twisted Pair cable
	Jitter
	<ul> <li>Jitter Normal With Twisted Pair cable</li> </ul>
	Jitter 8.0 With Twisted Pair cable
	Jitter 8.5 With Twisted Pair cable
	<ul> <li>Jitter Normal Without Twisted Pair cable</li> </ul>
	Jitter 8.0 Without Twisted Pair cable
	Jitter 8.5 Without Twisted Pair cable
	<ul> <li>MAU Internal</li> </ul>
	MAU External
	MAU Internal Inverted
	MAU External Inverted
	<ul> <li>Harmonic</li> </ul>

Parameters	Description	
	Transmitter Return Loss	
	Receiver Return Loss	
	CM Voltage	

### Table 22: ParameterName and Value for Acquisitions

ParameterName	Value
Source 1	Specifies the test mode source channel for each listed signal. Valid values are CH1 to CH4.
Source 2	Specifies the test mode source channel for each listed signal. Valid values are CH1 to CH4.
Source 3	Specifies the test mode source channel for each listed signal. Valid values are CH1 to CH4.
Aux	TRUE or FALSE
Show Acquire Parameters	TRUE or FALSE

### Table 23: ParameterName and Value for Preferences tab

Parameters	Description
Number of Runs	1 to 250
Acquire /Analyze each test	TRUE or FALSE
Action on Test measurement Failure	ON or OFF
Popup Settings	<ul> <li>Auto Close Warnings and Informations during Sequencing. Auto Close after (1 to 60) seconds</li> <li>Auto Close Error Message during Sequencing Show in Reports. Auto Close after (1 to 60) seconds</li> </ul>

### Table 24: ParameterName and Value for Acquire (1000BASE-T)

Test Name	Acquire Type	Parameter Name	Values
TemplateA_Without_Disturber	TemplateA_Without_Disturber	AcquisitionAverage	16 to 256
TemplateB_Without_Disturber	TemplateB_Without_Disturber	TriggerLevel (A)	-5 V to 5 V
TemplateC_Without_Disturber	TemplateC_Without_Disturber		
TemplateD_Without_Disturber	TemplateD_Without_Disturber	TriggerLevel (B)	-5 V to 5 V
TemplateF_Without_Disturber	TemplateF_Without_Disturber		
TemplateH_Without_Disturber	TemplateH_Without_Disturber		
TemplateA_With_Disturber	TemplateA_With_Disturber		
TemplateB_With_Disturber	TemplateB_With_Disturber		
TemplateC_With_Disturber	TemplateC_With_Disturber		
TemplateD_With_Disturber	TemplateD_With_Disturber		
TemplateF_With_Disturber	TemplateF_With_Disturber		
TemplateH_With_Disturber	TemplateH_With_Disturber		

Test Name	Acquire Type	Parameter Name	Values
PeakVoltageA_Without_Disturber PeakVoltageB_Without_Disturber PeakVoltageC_Without_Disturber PeakVoltageD_Without_Disturber DroopG_Without_Disturber DroopJ_Without_Disturber PeakVoltageA_With_Disturber PeakVoltageB_With_Disturber PeakVoltageD_With_Disturber DroopG_With_Disturber DroopG_With_Disturber Distortion_Without_Disturber_With_TX_TCL K	PeakVoltageA_Without_Disturber PeakVoltageB_Without_Disturber PeakVoltageC_Without_Disturber PeakVoltageD_Without_Disturber DroopG_Without_Disturber DroopJ_Without_Disturber PeakVoltageA_With_Disturber PeakVoltageB_With_Disturber PeakVoltageC_With_Disturber PeakVoltageD_With_Disturber DroopG_With_Disturber DroopG_With_Disturber Distortion_Without_Disturber_With_TX_TCL K Distortion_With_Disturber_Without_TX_TCL K	Acquisition Average	16 to 256
MasterFilter_Jitter_Without_TX_TCLK MasterUnfilter_Jitter_Without_TX_TCLK SlaveFilter_Jitter_Without_TX_TCLK SlaveUnfilter_Jitter_Without_TX_TCLK	MasterFilter_Jitter_Without_TX_TCLK MasterUnfilter_Jitter_Without_TX_TCLK SlaveFilter_Jitter_Without_TX_TCLK SlaveUnfilter_Jitter_Without_TX_TCLK	Measurement Duration Number Of Clock Edges	1 ms, 10 ms, 100 ms, 1000 ms 100000, 1000000, 1000000
MasterFilter_Jitter_With_TX_TCLK MasterUnfilter_Jitter_With_TX_TCLK SlaveFilter_Jitter_With_TX_TCLK SlaveUnfilter_Jitter_With_TX_TCLK	MasterFilter_Jitter_With_TX_TCLK MasterUnfilter_Jitter_With_TX_TCLK SlaveFilter_Jitter_With_TX_TCLK SlaveUnfilter_Jitter_With_TX_TCLK		
Transmitter Return Loss	ReturnLoss_Transmitter	Acquisition Average	100 to 10000
CM Voltage	CM Voltage		

### Table 25: ParameterName and Value for Acquire (100BASE-T)

Test Name	Acquire Type	Parameter Name	Values
AOI_Template	AOI_Template	Number of samples	5000 to 2147400000
Fall_Time_Pos	Fall_Time_Pos	Acquisition Type	Sample, Average
Fall_Time_Neg Rise_Time_Pos Rise_Time_Neg RF_Symmetry_Pos RF Symmetry_Neg Overshoot_Pos Overshoot_Neg Differential_Output Voltage_Pos Difftrerential_Output_Voltage_Neg Amplitude_Symmetry	Fall_Time_Neg Rise_Time_Pos Rise_Time_Neg RF_Symmetry_Pos RF Symmetry_Neg Overshoot_Pos Overshoot_Neg Differential_Output Voltage_Pos Difftrerential_Output_Voltage_Neg Amplitude_Symmetry	Number of Waveforms	2 to 10000
Duty Cycle Distortion	Duty Cycle Distortion	Acquisition Type	Sample, Average
Transmitter Return Loss	ReturnLoss_Transmitter	Acquisition Average	100 to 10000
Receiver Return Loss	ReturnLoss_Receiver		

### Table 26: ParameterName and Value for Acquire (10BASE-T)

Test Name	Acquire Type	Parameter Name	Values
Link Pulse Timing Load1 With Twisted Pair cable Link Pulse Timing Load2 With Twisted Pair cable Link Pulse Timing Load3 With Twisted Pair cable Link Pulse Timing Load1 Without Twisted Pair cable Link Pulse Timing Load2 Without Twisted Pair cable Link Pulse Timing Load3 Without Twisted Pair cable	cable Link Pulse Load2 With Twisted Pair cable		2 to 10000 1 to 10000
Differential Voltage	Differential Voltage	Acquisition Average	2 to 1000
		Acquisition Delay	1 to 10000 (Micro- seconds)
		Acquisition Type	<ul><li>Sample</li><li>Average</li></ul>
TP_IDL Load2 With Twisted Pair cable	TP_IDL Load1 With Twisted Pair cable TP_IDL Load2 With Twisted Pair cable TP_IDL Load3 With Twisted Pair cable TP_IDL Load1 Without Twisted Pair cable TP_IDL Load2 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable	Number of Waveforms	2 to 10000 1 to 10000
Jitter Normal With Twisted Pair Cable Jitter 8.0 With Twisted Pair Cable Jitter 8.5 With Twisted Pair Cable Jitter Normal Without Twisted Pair Cable Jitter 8.0 Without Twisted Pair Cable Jitter 8.5 Without Twisted Pair Cable	Jitter Normal With Twisted Pair Cable Jitter 8.0 With Twisted Pair Cable Jitter 8.5 With Twisted Pair Cable Jitter Normal Without Twisted Pair Cable Jitter 8.0 Without Twisted Pair Cable Jitter 8.5 Without Twisted Pair Cable	Number of Acquisitions	2 to 10000
MAU Internal MAU External MAU Internal Inverted MAU External Inverted	MAU Internal MAU External MAU Internal Inverted MAU External Inverted		1000 to 10000
Harmonic	Harmonic	Acquisition Delay	1 to 10000 (Micro- seconds)
		Math Average	2 to 10000
Transmitter Return Loss	Transmitter Return Loss	Acquisition Average	100 to 10000
Receiver Return Loss	Receiver Return Loss		
CM Voltage	CM Voltage		

### Table 27: ParameterName and Value for Analyze (1000BASE-T)

Test Name	Acquisition Type	Parameter Name	Values
TemplateA_Without_Disturber TemplateB_Without_Disturber TemplateC_Without_Disturber TemplateD_Without_Disturber TemplateF_Without_Disturber TemplateA_With_Disturber TemplateA_With_Disturber TemplateB_With_Disturber TemplateC_With_Disturber TemplateF_With_Disturber TemplateF_With_Disturber TemplateF_With_Disturber PeakVoltageA_Without_Disturber PeakVoltageA_Without_Disturber PeakVoltageD_Without_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageB_With_Disturber PeakVoltageB_With_Disturber PeakVoltageD_With_Disturber PeakVoltageD_With_Disturber PeakVoltageD_With_Disturber	TemplateA_Without_Disturber TemplateB_Without_Disturber TemplateC_Without_Disturber TemplateD_Without_Disturber TemplateF_Without_Disturber TemplateA_With_Disturber TemplateA_With_Disturber TemplateB_With_Disturber TemplateC_With_Disturber TemplateF_With_Disturber TemplateF_With_Disturber TemplateF_With_Disturber PeakVoltageA_Without_Disturber PeakVoltageC_Without_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageA_With_Disturber PeakVoltageC_With_Disturber PeakVoltageD_With_Disturber PeakVoltageD_With_Disturber	External Filter	<ul> <li>Include</li> <li>Exclude</li> </ul>
Distortion_Without_Disturber_Without_TX_T CLK Distortion_With_Disturber_Without_TX_TCL K	Distortion_Without_Disturber_Without_TX_T CLK Distortion_With_Disturber_Without_TX_TCL K	LP Filter Hi Resolution	<ul><li>Include</li><li>Exclude</li><li>16 to 64</li></ul>
MasterFilter_Jitter_Without_TX_TCLK MasterUnfilter_Jitter_Without_TX_TCLK SlaveFilter_Jitter_Without_TX_TCLK SlaveUnfilter_Jitter_Without_TX_TCLK MasterFilter_Jitter_With_TX_TCLK SlaveFilter_Jitter_With_TX_TCLK SlaveFilter_Jitter_With_TX_TCLK SlaveUnfilter_Jitter_With_TX_TCLK	MasterFilter_Jitter_Without_TX_TCLK MasterUnfilter_Jitter_Without_TX_TCLK SlaveFilter_Jitter_Without_TX_TCLK SlaveUnfilter_Jitter_Without_TX_TCLK MasterFilter_Jitter_With_TX_TCLK SlaveFilter_Jitter_With_TX_TCLK SlaveFilter_Jitter_With_TX_TCLK	Clock Edge Hysteresis	<ul> <li>RISE</li> <li>FALL</li> <li>0% to 10%</li> </ul>
Transmitter Return Loss	ReturnLoss_Transmitter	Smoothing Averages Load (Ohm)	1 to 10
CM Voltage	CM Voltage	Filter Type	<ul> <li>None</li> <li>1 MHZ (High Pass)</li> <li>100 MHZ (Low Pass)</li> <li>1-100 MHZ (Base band)</li> </ul>

### Table 28: ParameterName and Value for Analyze (100BASE-T)

Test Name	Acquisition Type	Parameter Name	Values
Transmitter Return Loss	Transmitter Return Loss	Smoothing Averages	1 to 10
Receiver Return Loss	Receiver Return Loss	Load(Ohm)	<ul><li>85, 100, 115</li><li>100</li></ul>
AOI_Template	AOI_Template	Fail Threshold	1 to 5000
Jitter Pos Jitter Neg	Jitter Pos Jitter Neg	Measurement Type	<ul><li>Tie</li><li>Histogram</li></ul>

### Table 29: ParameterName and Value for Analyze (10BASE-T)

Test Name	Acquire Type	Parameter Name	Values
Link Pulse Load1 With Twisted Pair cable Link Pulse Load2 With Twisted Pair cable Link Pulse Load3 With Twisted Pair cable Link Pulse Load1 Without Twisted Pair cable Link Pulse Load2 Without Twisted Pair cable Link Pulse Load3 Without Twisted Pair cable TP_IDL Load1 With Twisted Pair cable TP_IDL Load2 With Twisted Pair cable TP_IDL Load3 With Twisted Pair cable TP_IDL Load1 Without Twisted Pair cable TP_IDL Load2 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable MAU Internal MAU External MAU Internal Inverted MAU External Inverted	Link Pulse Load1 With Twisted Pair cable Link Pulse Load2 With Twisted Pair cable Link Pulse Load3 With Twisted Pair cable Link Pulse Load3 Without Twisted Pair cable Link Pulse Load2 Without Twisted Pair cable Link Pulse Load3 Without Twisted Pair cable TP_IDL Load1 With Twisted Pair cable TP_IDL Load2 With Twisted Pair cable TP_IDL Load3 With Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable TP_IDL Load3 Without Twisted Pair cable MAU Internal MAU External MAU Internal Inverted MAU External Inverted	Fail Threshold	1 to 5000
Link Pulse Timing Load1 With Twisted Pair cable Link Pulse Timing Load2 With Twisted Pair cable Link Pulse Timing Load3 With Twisted Pair cable Link Pulse Timing Load1 Without Twisted Pair cable Link Pulse Timing Load2 Without Twisted Pair cable Link Pulse Timing Load3 Without Twisted Pair cable Jitter Normal with Twisted Pair cable Jitter 8.0 with Twisted Pair cable Jitter 8.5 with Twisted Pair cable Jitter 8.0 without Twisted Pair cable Jitter 8.0 without Twisted Pair cable Jitter 8.0 without Twisted Pair cable	Twisted Pair cable Link Pulse Timing Load3 Without Twisted Pair cable Jitter Normal with Twisted Pair cable Jitter 8.0 with Twisted Pair cable Jitter 8.5 with Twisted Pair cable	MAU Type	<ul> <li>Internal</li> <li>External</li> </ul>

Test Name	Acquire Type	Parameter Name	Values
Differential Voltage	Differential Voltage	Peak	<ul><li>Min</li><li>MinMax</li></ul>
Transmitter Return Loss Receiver Return Loss	Transmitter Return Loss Receiver Return Loss	Smoothing Average Load (Ohm)	1 to 10

**ParameterName and Value for General, Acquire and Analyze**: Specifies the ParameterName and Value for General, Acquire, and Analyze.

#### Table 30: ParameterName and Value for General

ParameterName	Value
Report Update Mode	New
	Append
	Replace
	■ in previous run, current session
	in any run, any session
Report name	X:\Ethernet\Reports\DUT001.mht
Auto increment report name if duplicate	Included
	Excluded
Create report automatically at the end of the run	Included
	Excluded
Include pass/fail results Summary	Included
	Excluded
Include detailed results	Included
	Excluded
Include plot images	Included
	Excluded
Include setup configuration	Included
	Excluded
Include complete configuration	Included
	Excluded

ParameterName	Value
Include user comments	Included
	Excluded
View report after generating	Included
	Excluded
Save As type	Web Archive (*.mht;*.mhtml)
	PDF (*.pdf)
	■ CSV (*.csv;)

# Examples

This section provides the examples for the SCPI commands.

Example	Description
TEKEXP:*IDN?	It returns the active TekExpress application name running on the scope.
TEKEXP:*OPC?	It returns the last command execution status.
TEKEXP:ACQUIRE_MODE PRE-RECORDED	It sets the acquire mode as pre-recorded.
TEKEXP:ACQUIRE_MODE?	It returns LIVE when acquire mode is set to live.
TEKEXP:EXPORT REPORT	It returns the report file in bytes. This can be written into another file for further analysis.
TEKEXP:INFO? REPORT	It returns "100,"ReportFileName.mht"", when 100 is the filesize in bytes for the filename ReportFileName.
TEKEXP:INFO? WFM	It returns "100,"WfmFileName1.wfm"";"200,"WfmFileName2.wfm"" when 100 is the filesize in bytes for the filename WfmFileName1.wfm and 200 is the filesize in bytes for the filename WfmFileName2.wfm.
TEKEXP:INSTRUMENT "Real Time Scope",MSO58 (GPIB8::1::INSTR)	It sets the instrument value as MSO58 ( GPIB8::1::INSTR ) for the selected instrument type Real Time Scope.
TEKEXP:INSTRUMENT? "Real Time Scope"	It returns "MSO58 ( GPIB8::1::INSTR ), when MSO58 ( GPIB8::1::INSTR )" is the selected instrument for the instrument type Real Time Scope.
TEKEXP:LASTERROR?	It returns ERROR: INSTRUMENT_NOT_FOUND, when no instrument is found.
TEKEXP:LIST? DEVICE	It returns "Ethernet Tx" when Ethernet Tx application is the available device.
TEKEXP:LIST? INSTRUMENT,"Real Time Scope"	It returns "MSO58 ( GPIB8::1::INSTR ),MSO64 ( TCPIP:: 134.64.248.91::INSTR )" when MSO58 ( GPIB8::1::INSTR ), MSO64 ( TCPIP::134.64.248.91::INSTR ) are the list of available instruments.

Example	Description
TEKEXP:MODE COMPLIANCE	It sets the execution mode as compliance.
TEKEXP:MODE?	It returns COMPLIANCE when the execution mode is compliance.
TEKEXP:POPUP "OK"	It sets OK as the response to active popup in the application.
TEKEXP:POPUP?	It returns "OK", when OK is the active popup information shown in the application.
TEKEXP:REPORT GENERATE	It generates report for the current session.
TEKEXP:REPORT? "Scope Model"	It returns "MSO58" when MSO58 is the scope model.
TEKEXP:REPORT? "DUT ID"	It returns "DUT001" when DNI_DUT001 is the DUT ID.
TEKEXP:RESULT? "PeakVoltageD_Without_Disturber"	It returns Pass, then the test result is Pass.
TEKEXP:RESULT? "PeakVoltageD_Without_Disturber", "Margin"	It returns list of values then that is 'Margin' column data.
TEKEXP:RESULT? "PeakVoltageD_Without_Disturber", "Units",0	It returns the unit of the first row of result.
TEKEXP:SELECT DEVICE, "TekExpress Ethernet"	It selects device "TekExpress Ethernet".
TEKEXP:SELECT TEST,"TemplateA_Without_Disturber", TRUE	It selects "TemplateA_Without_Disturber" measurement.
TEKEXP:SETUP DEFAULT	It restores the application to default setup.

# References

### 1000BASE-T

This measurement verifies that the transmitter output fits the time domains 1000BASE-T template transmit templates. **Reference:** Subclause 40.6.1.2.3 of IEEE standard 802.3-2015 Description According to standard, the Test Mode 1 signal from the DUT needs to be normalized. This should be compared to the differential output templates shown in Figure 40-26 of the standard. The normalization factors to be applied to various points: For Point A: Normalization with the peak voltage at point A. For Point B: Normalization with the negative of peak voltage at point A. For Point C: Normalization with 0.5 times the peak voltage at point A. For Point D: Normalization with the negative of 0.5 times the peak voltage at point A. For Point F and H: The waveform around points F and H are compared to time domain transmit template 2 after the following normalization factors are applied: Normalization with the peak voltage at point F. Normalization with the peak voltage at point H. According to standard, the waveform can be shifted in time to fit the template.

#### **1000BASE-T peak voltage** This measurement verifies the transmitter output levels.

#### **Reference:**

Subclause 40.6.1.2.1 of IEEE standard 802.3-2015

#### Description

According to standard, magnitude of peak differential output voltage measure at points A and B should be between 670 and 820 mV. Also, these conditions should be met:

$$abs\left(\frac{|PeakVoltageB| - \left(\frac{|PeakVoltageB| + |PeakVoltageA|}{2}\right)}{\frac{|PeakVoltageB| + |PeakVoltageA|}{2}}\right) < 1\%$$

 $\frac{|\text{PeakVoltageC}|}{|\text{PeakVoltaageD}|} < 2\% \text{ of } 0.5 \text{ times } \frac{|\text{PeakVoltageA}| + |\text{PeakVoltageB}|}{2}$ 

**1000BASE-T droop** This measurement verifies that the transmitter output level does not decay faster than the maximum specified rate.

#### **Reference:**

Subclause 40.6.1.2.2 of IEEE standard 802.3-2015

#### Description

According to standard, the Point G and J are exactly 500 ns from Points F and H respectively. The magnitude of voltage at Point G should be greater than 73.1% magnitude of voltage at Point F and magnitude of voltage at Point J should be greater than 73.1% magnitude of voltage at Point H.

### 1000BASE-T jitter (with TX\_TCLK)

This measurement verifies that the transmitter output level does not reduce faster than the maximum specified rate.

#### **Reference:**

Subclause 40.6.1.2.5 of IEEE standard 802.3-2015

#### Description

Jitter Master Unfiltered — According to the standard, the peak-to-peak value of jitter waveform on MASTER TX\_TCLK relative to unfiltered reference should be less than 1.4 ns.

Jitter Master Filtered — According to the standard, the peak-to-peak value of jitter waveform on MASTER TX\_TCLK when filtered by a high pass filter,

with the transfer function below + JTx out of Data related to the corresponding edge of MASTER TX\_TCLK should be less than 0.3 ns.

$$H_{jf1}(f) = \frac{jf}{jf + 5000} f \text{ in Hz}$$

Jitter Slave Unfiltered — According to the standard, the peak-to-peak value of jitter waveform on SLAVE TX\_TCLK relative to unfiltered reference should be less than 1.4 ns.

Jitter Slave Filtered —According to the standard, the peak-to-peak value of jitter waveform on SLAVE TX\_TCLK when filtered by a high pass filter,  $H_{jf2}(f)$  with the transfer function below + JTx out of data related to the corresponding edge of SLAVE TX\_TCLK should be less than 0.4 ns + peak-to-peak value of jitter waveform on MASTER TX\_TCLK when filtered by a high pass filter,  $H_{if1}(f)$ .

$$H_{jF2}(f) = \frac{jf}{jf + 32000} f \text{ in Hz}$$

**NOTE**. J denotes the square root of -1.

**1000BASE-T jitter (without** TX\_TCLK) To provide an analysis of the Transmitter Timing Jitter test method defined in Clause 40.6.1.2.5 of IEEE 802.3-2002, and to propose an alternative method that may be used in cases where a device does not provide access to the TX\_TCLK signal.

#### **Reference:**

- 1. IEEE standard 802.3-2015, subclause 40.6.1.1.1 Test channel
- 2. Ibid., subclause 40.6.1.1.2, figure 40-20 Test modes
- 3. Ibid., subclause 40.6.1.1.3, figure 40-25 Test fixtures
- 4. Ibid., subclause 40.6.1.2.5 Transmitter Timing Jitter
- 5. Test suite appendix 40.6.A 1000BASE-T transmitter test fixtures

**NOTE.** The references mentioned here are proposed, and not part of a standard. This is an alternate test method for jitter measurement being proposed, when  $TX_TCLK$  is not accessible. This is an informal test method.

#### **Transmitting Timing Jitter (Alternate Method):**

Jitter Master Unfiltered — The peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference should be less than 1.4 ns (pass).

The peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference should be more than 1.4 ns (inconclusive).

Jitter Master Filtered — The peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference, when filtered by a high pass filter,  $H_{ifl}(f)$  with the transfer function below should be less than 0.3 ns (pass).

The peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference, when filtered by a high pass filter,  $H_{jfl}(f)$  with the transfer function below should be more than 0.3 ns (inconclusive).

$$H_{jf1}(f) = \frac{jf}{jf + 5000} f \text{ in Hz}$$

Jitter Slave Unfiltered — The difference between the peak-to-peak value of jitter waveform on data in Test Mode 3 relative to unjittered reference and the peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference should be less than 1.4 ns (pass).

The difference between the peak-to-peak value of jitter waveform on data in Test Mode 3 relative to unjittered reference and the peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference should be more than 1.4 ns (fail).

Jitter Slave Filtered — The difference between the peak-to-peak value of jitter waveform on data in Test Mode 3 relative to unjittered reference, when filtered by a high pass filter,

 $H_{jfl}(f)$  with the transfer function below, and the peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference, when filtered by a high pass filter,

 $H_{ifl}(f)$  with the transfer function below, should be less than 0.4 ns (pass).

The difference between the peak-to-peak value of jitter waveform on data in Test Mode 3 relative to unjittered reference, when filtered by a high pass filter,

 $H_{jfl}(f)$  with the transfer function below, and the peak-to-peak value of jitter waveform on data in Test Mode 2 relative to unjittered reference, when filtered by a high pass filter,

 $H_{ifl}(f)$  with the transfer function below, should be more than 0.4 ns (fail).

$$H_{jf1}(f) = \frac{jf}{jf + 5000} f \text{ in Hz}$$

$$H_{jF2}(f) = \frac{jf}{jf + 32000} f \text{ in Hz}$$

**1000BASE-T distortion** This measurement verifies that the peak transmitter distortion of the DUT is less than 10 mV for at least 60% of the UI within the eye-opening.

#### **Reference:**

IEEE standard 802.3-2015, sub clause 40.6.1.2.4

PMA Test suite, version 2.5, Test 40.1.6

#### Description

The peak distortion of the Test Mode 4 differential signal, when sampled with the symbol rate TX\_TCLK at an arbitrary phase and processing this block of any 2047 consecutive samples, should be less than 10 mV.

1000BASE-T return loss	This measurement verifies that the Return Loss of the Device Under Test (DUT) is above the conformance limit.
	Reference:
	Subclause 40.8.3.1 of IEEE standard 802.3-2015
	Description
	At least 16 dB over the frequency range of 1.0 MHz to 40 MHz and at least 10 -20 $\log 10 (f/80)$ dB over the frequency range 40 MHz to 100 MHz (f in MHz).
1000BASE-T CM voltage	This measurement verifies that the common-mode voltage of the DUT is within the conformance limits.
	Reference:
	Subclause 40.8.3.3 of IEEE standard 802.3-2015
	Description
	The magnitude of the total common-mode output voltage, Ecm_out, on any transmit circuit, shall be less than 50 mV peak-to-peak when transmitting data at frequencies above 1 MHz.
100BASE-T	

	Reference:
	transmit template.
100BASE-T template	This measurement verifies that the transmitter output fits the time domain

Annex J of ANSIX3.263-1995

### Description

According to standard, Active Output Interface (AOI) transmitting scrambled Halt Line State should fit in the template.

100BASE-T differential output voltage	This measurement verifies that the differential output voltage of the device under test (DUT) is within the conformance limits.
	Reference:
	Subclause 9.1.2.2 of ANSI X3.263-1995
	Description
	According to standard, differential output voltage ( $V_{out}$ ) should lie in the range of 950 mV to 1050 mV in both positive and negative excursion.
100BASE-T signal amplitude symmetry	This measurement verifies that the signal amplitude symmetry of the device under test (DUT) is within the conformance limits.
	Reference:
	Subclause 9.1.4 of ANSI X3.263-1995
	Description
	The ratio of the + $V_{out}$ magnitude to - $V_{out}$ magnitude shall be between the limits:
	$0.98 \le  +V_{out}  /  -V_{out}  \le 1.02$
100BASE-T rise and fall time	This measurement verifies that the response times of the DUT are within the conformance limits.
	Reference:
	Subclause 9.1.6 of ANSI X3.263-1995
	Description
	Active Output Interface (AOI) rise and fall time shall be in the range of 3.0 ns and 5.0 ns. Rise and fall times are defined as time difference between 10% and 90% voltage levels. Both positive and negative rise/fall times should be validated.
	The difference between the maximum and the minimum of all measured rise and fall times should be less than 0.5 ns.

100BASE-T waveform overshoot	This measurement verifies that the waveform overshoot of the DUT is below the conformance limit.
	Reference:
	Subclause 9.1.3 of ANSI X3.263-1995
	Description
	According to standard, Overshoot is the percentage excursion of the differential signal transition beyond Vout. Differential signal overshoot should not exceed 5%. Both positive and negative overshoot are to be measured.
100BASE-T Jitter	This measurement verifies the jitter of the DUT is within the conformance limits.
	Reference:
	Subclause 9.1.9 of ANSI X3.263-1995
	Description
	The transmitter output jitter when measured at the output of the twisted-pair model should lie within $\pm 5.5$ ns. As per B.4.3.3 Note for 14.3.1.2.3 of IEEE standard 802.3-2015, failure of this test does not demonstrate noncompliance.
	The transmitter output jitter when measured without the twisted-pair model should lie within $\pm 8.0$ ns.
100BASE-T return loss	This measurement verifies the return loss at the transmitter or receiver of the device under test (DUT) is above the conformance limit.
	Reference:
	Subclause 9.1.5 and 9.2.2 of ANSI X3.263-1995
	Description
	Greater than 16 dB from 2 MHz to 30 MHz.
	Greater than (16-20log(f/30 MHz)) dB from 30 MHz to 60 MHz.
	Greater than 10 dB from 60 MHz to 80 MHz.

100BASE-T duty cycle distortion	This measurement verifies that the duty cycle distortion of the DUT is below the conformance limit.
	Reference:
	Subclause 9.1.3 of ANSI X3.263-1995
	Description
	According to standard, duty cycle distortion should be measured at the 50% voltage points on rise and fall transitions of the differential output waveform and should not exceed $\pm 0.25$ ns.
10BASE-T	
10BASE-T MAU Ext	This measurement verifies that the transmitter output equalization meets standard specifications.
	Reference:
	Subclause 14.3.1.2.1 of IEEE standard 802.3-2015
	Description
	According to standard, the transmitter waveform should lie within the template (Normal and Inverted) for all data sequences at the twisted-pair model's output with 100 Ohm termination.
10BASE-T MAU Int	This measurement verifies that the transmitter output equalization meets standard specifications.
	Reference:
	Subclause 14.3.1.2.1 of IEEE standard 802.3-2015
	Description
	According to standard, the transmitter waveform should lie within the template (Normal and Inverted) for all data sequences at the twisted-pair model's output with 100 Ohm termination.

10BASE-T TP_IDL	This measurement verifies that the transmitter functions properly after a transition to the idle state.
	Reference:
	Subclause 14.3.1.2.1 of IEEE standard 802.3-2015
	Description
	According to standard, the TP_IDL pulse should lie within the template. This test shall be done across each of the specified test loading Load 1, Load 2, and Load 3 with and without twisted-pair model.
10BASE-T link pulse	This measurement verifies that the link test pulse waveforms meet specification.
	Reference:
	Subclause 14.3.1.2.1 of IEEE standard 802.3-2015
	Description
	According to standard, the link test pulse should lie within the template. This test shall be done across each of the specified test loading Load 1, Load 2, and Load 3 with and without twisted-pair model.
10BASE-T differential voltage	This measurement verifies that the differential voltage of the DUT is within the conformance limits.
	Reference:
	Subclause 14.3.1.2.1 of IEEE standard 802.3-2015
	Description
	Peak differential voltage of transmitter waveform when terminated with a 100 Ohm resistor should lie between 2.2 V and 2.8 V for all data sequences.
10BASE-T harmonic	This measurement verifies that the harmonic content of the DUT is within the conformance limits.
	Reference:
	Subclause 14.3.1.2.1 of IEEE standard 802.3-2015
	Description
	Harmonic test is done when the DO circuit is driven by all ones. Each harmonic measured at the output of the transmitter shall be at least 27 dB below the fundamental.

10BASE-T return loss	This measurement verifies the return loss at the transmitter or receiver of the device under test (DUT) is above the conformance limit.
	Reference
	Subclause 14.3.1.2.2 of IEEE standard 802.3-2015 ab
	Description
	At least 15 dB over the frequency range of 5.0 to 10 MHz.
10BASE-T jitter	This measurement verifies the jitter of the DUT is within the conformance limits.
	Reference:
	Subclause 14.3.1.2.3 of IEEE standard 802.3-2015
	Annexure B.4.3.2 Note for 14.3.1.2.3 of IEEE standard 802.3-2015
	Description
	The transmitter output jitter when measured at the output of the twisted-pair model should lie within $\pm 5.5$ ns. As per B.4.3.3 Note for 14.3.1.2.3 of IEEE standard 802.3-2015, failure of this test does not demonstrate noncompliance.
	The transmitter output jitter when measured without the twisted-pair model should lie within $\pm 8.0$ ns.
10BASE-T CM Voltage	This measurement verifies that the common-mode voltage at the transmitter or receiver of the device under test (DUT) is above the conformance limit.
	Reference:
	Subclause 14.3.1.2.5 of IEEE standard 802.3-2015
	Description
	At least 15 dB over the frequency range of 5.0 to 10 MHz.

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